

HC32L031 Series

32-bit ARM[®] Cortex[®]-M0+ Microcontroller

Datasheet

Rev1.20
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Feature List

Support Features

- 48MHz Cortex-M0+ 32-bit CPU platform
- HC32L031 Series has a flexible power management system:
 - ▶ 0.65μA@3V DeepSleep mode: all clocks off, power-on reset active, IO state retention, IO interrupt active, all registers, RAM and CPU data save state power consumption
 - ▶ 45μA/MHz@3V@48MHz Operating Mode: CPU running, peripherals off, program running from Flash
- 64KB FLASH memory, with erase and write protection function, supports ISP, ICP, IAP, security protection level-4
- 8KB RAM memory
- GPIO: 29IO/32pin, 21IO/24pin(4mm*4mm), 22IO/24pin(3mm*3mm)
 - ▶ Selected IOs support input filtering
- Clock, Crystal
 - ▶ RC48M: 4/6/32/48MHz
 - ▶ RCL: 32.768/38.4kHz
 - ▶ XTL: 32.768kHz
 - ▶ Support external clock source input
- Timer/Counter
 - ▶ 2 CTIMs. Each CTIM can be configured either as one 16-bit General-Purpose Timer (GTIM) or as three 16-bit Basic Timers (BTIMs). In GTIM mode, it supports 4-channel capture/compare and 4-channel PWM output. In BTIM mode, each timer provides two toggle outputs
 - ▶ 1 advanced 16-bit timer (ATIM3) supporting 3-phase PWM outputs with dead-time insertion for complementary pairs
 - ▶ 1 low-power timer, support PWM output
 - ▶ 1 Independent Watchdog, Internal Low-Speed Clock provides IWDG counting
 - ▶ 1 CTRIM module supporting ultra-low-power timing functions, enabling extended intervals up to 65,536s with auto-wakeup capability, and featuring internal clock real-time calibration
- ▶ 1 RTC calendar/counter module with up to 0.06ppm compensation accuracy
- ▶ 1 CM0+ integrated 24-bit SysTick timer
- Communication interface
 - ▶ 1-channel USART communication interface, support 7816, LIN, IR
 - ▶ 2-channel LPUART communication interface
 - ▶ 2-channel SPI standard communication interface
 - ▶ 2-channel I2C communication interface
- 1-way TRNG: 64-bit Random Number Generator
- 2-channel DMAC
- Globally unique 10-byte ID number
- Integrate a high-speed and high-precision SAR ADC with a 12-bit 1Msps sampling
- 2 VCs, configurable with 64-step reference voltage ladder and 12 selectable filter levels
- Integrate a LVD supporting 16 programmable threshold levels, 12 configurable filter settings, and dual monitoring capability for both port voltages and power supply voltages
- SWD debugging solution provides a full-featured debugger
- Working conditions: -40-105°C, 1.8-5.5V
- Package: LQFP32, QFN32/24

Typical Application

- Motor control, battery management
- Smart home, medical devices
- Security alarms, intelligent transportation
- Sensor modules, wireless modules, electronic shelf labels

Support Model

HC32L031F8UB-QFN32TR	HC32L031F8TB-LQ32
HC32L031D8UB-QFN24TR	HC32L031D8UB-UFN24TR

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Preface

Number Format

- 0x prefix is used for hexadecimal numbers
- 0b prefix is used for binary numbers
- Numbers without prefix are in decimal representation

Security Statement

There may be potential security problems due to the use of a certain function or protocol, which need to be declared to remind users and avoid security risks.

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1 Product Overview

1.1 Product Lineup

Product Name

	HC	32	L	0	3	1	F	8	U	B
XiaoHua Semiconductor										
MCU Family										
32: 32-bit										
Product Type										
L: Ultra-low power										
MCU Platform										
0: Cortex-M0+										
MCU Specification Grade										
3: Mainstream										
Feature Configuration										
1: Configuration 1										
Pins										
D: 24 Pin										
F: 32 Pin										
Program Capacity										
8: 64KB										
Package										
T: LQFP										
U: QFN										
Temperature Grade										
B: -40-105°C, industrial level										

Model Function Comparison Table

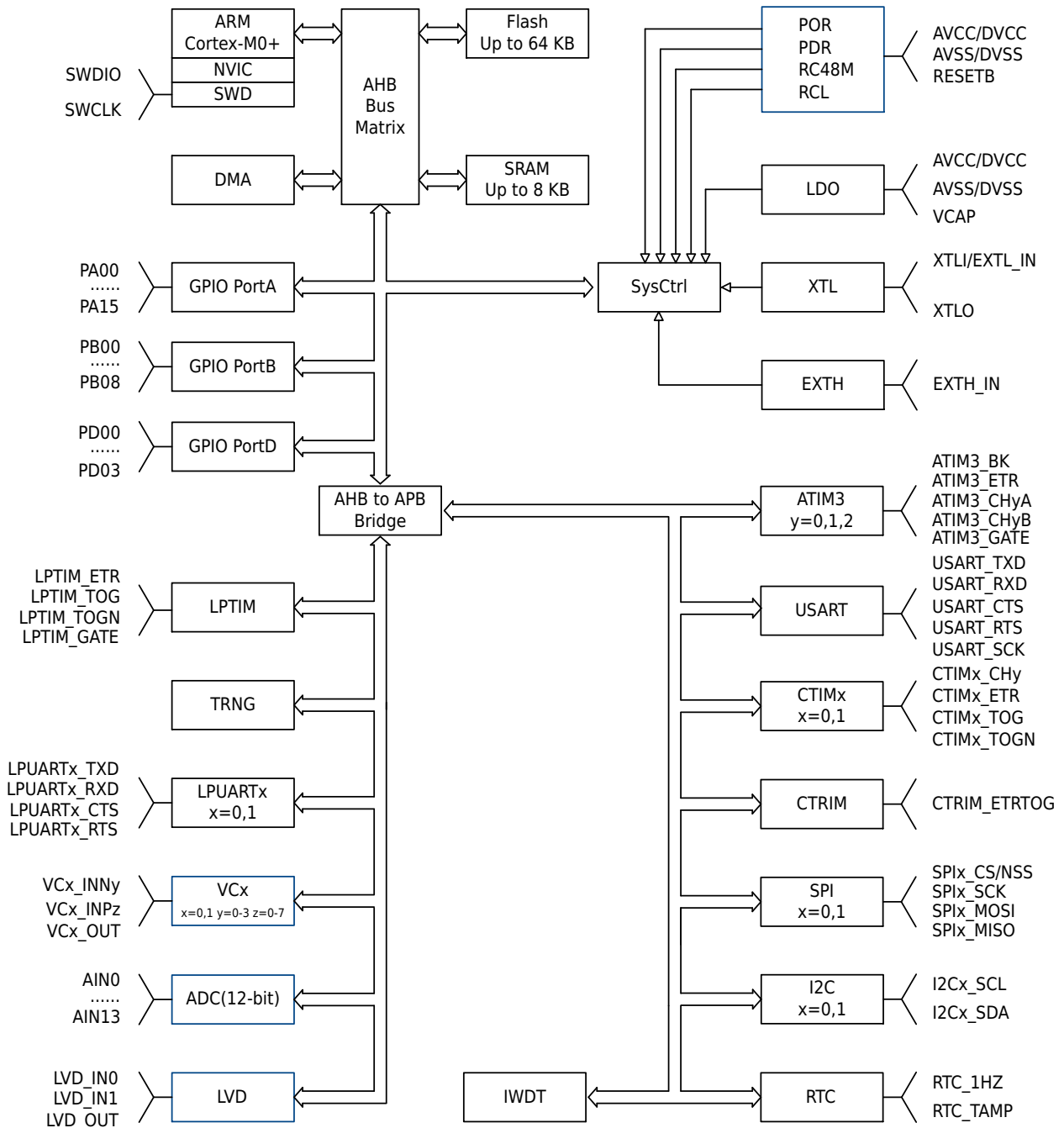
Product Name		HC32L031F8UB	HC32L031F8TB	HC32L031D8UB (4mm*4mm)	HC32L031D8UB (3mm*3mm)
Pins		32		24	
GPIOs		28+1 ⁽¹⁾		20+1 ⁽¹⁾	21+1 ⁽¹⁾
CPU	Core	Cortex-M0+			
	Frequency	48MHz			
Memory	Flash	64KB			
	RAM	8KB			
Clock	RC48M	4/6/32/48MHz			
	RCL	32.768/38.4kHz			
	EXTH	4-24MHz			
	XTL	32.768kHz			
Power Voltage Range		1.8-5.5V			
Single/dual Power Supply		Single power supply			
Temperature Range		-40-105℃			
Port Interrupt		29		21	22
DMAC		2ch			
Timer		General Timer CTIM0/1		General Timer CTIM0 ⁽²⁾ General Timer CTIM1	General Timer CTIM0/1
		Advanced Timer ATIM3			
		Clock Calibration Timer CTRIM (supports low-power timer mode)			
		Low Power Timer LPTIM			
RTC		1			
IWDT		1			
Connectivity		LPUART0/1			
		USART (can be multiplexed for 7816, LIN, IR)			
		I2C0/1			
		SPI0/1			
ADC, 12-bit		14ch+2 (AVCC/3, VCAP)		10ch+2 (AVCC/3, VCAP)	11ch+2 (AVCC/3, VCAP)
VC		VC0/1			
LVD		1			
Flash Security Protection		Support			
TRNG		Support			
Debug Function		SWD debug/programming interface			
Unique Identification Code		Support (80bits)			
Package (mm*mm)		QFN32 (4*4)	LQFP32 (7*7)	QFN24 (4*4)	QFN24(3*3)



Note

1. When the MCU is in the running state, the RESET pin can be reused as a GPIO input function.
2. The partial output functions of CTIM0 are restricted.

1.2 Functional Block Diagram



Note

Products in different packages support varying resources. For detailed specifications, please refer to [Model Function Comparison Table](#).

2 Functional Description

2.1 32-bit Cortex-M0+ Core

The ARM Cortex-M0+ processor is based on the Cortex-M0 and integrates a 32-bit RISC processor with a computing performance of 0.95 Dhrystone MIPS/MHz. It also incorporates multiple new designs, including improved debugging and tracing capabilities, reduced instructions per cycle (IPC) count, an enhanced two-stage pipeline for Flash access, and integrates energy-saving technologies. The Cortex-M0+ processor fully supports Keil & IAR debuggers.

The Cortex-M0+ includes a hardware debug circuit supporting the 2-pin SWD debug interface.

ARM Cortex-M0+ support features:

Instruction set	Thumb/Thumb-2
Assembly line	2-stage assembly line
Performance efficiency	2.46 CoreMark/MHz
Performance efficiency	0.95 DMIPS/MHz in Dhrystone
Interrupt	32 fast interrupts (For detailed interrupt specifications of this product, please refer to " NVIC ")
Interrupt priority	Configurable 4-level interrupt priority
Enhanced instruction	Multi-cycle 32-bit multiplier
Debugging	Serial-wire debug port, supports four break points and one watch point.

2.2 64KB FLASH

Built-in fully integrated FLASH controller, no need for external high voltage input, high voltage generated by the fully built-in circuit for programming. Supports ISP, IAP, ICP functions. Features 4-level security protection.

2.3 8KB RAM

RAM data is retained in any power mode.

2.4 Clock System

- A high-precision internal RC48M clock with configurable frequencies of 4/6/32/48MHz.
- An internal RCL clock with frequencies of 32.768/38.4kHz.
- An external high-speed clock source EXTH with a frequency range of 4-24MHz.
- An external 32.768kHz crystal oscillator XTL, primarily providing the RTC real-time clock.

2.5 Operating Mode

1. Active Mode: CPU running, peripheral functional modules running.
2. Sleep mode: CPU halted, peripheral functional modules running.
3. DeepSleep mode: CPU halted, high-speed clock modules disabled.

2.6 RTC

The RTC (Real-Time Clock) is a functional module supporting BCD data format, typically using a 32.768kHz crystal as its clock. It enables perpetual calendar functionality with configurable interrupt periods: month/day/hour/minute/second. 24/12 hour time mode, the hardware automatically corrects leap years. It features precision compensation, supporting either 0.96ppm or 0.06ppm precision. Software adjustments of +1/-1 are available for year/month/day/hour/minute/second, with a minimum adjustable precision of one second.

The RTC calendar recorder used to indicate time and date does not reset the register when the MCU is reset by external factors.

2.7 GPIO

It can provide up to 29 GPIO ports, some of which are multiplexed with analog ports. Each port is controlled by independent control register bits. Supports edge-triggered interrupts and level-triggered interrupts, and can wake up the MCU to working mode from various ultra-low power consumption modes. Supports bit set, bit clear, and bit set clear operations. Supports CMOS Push-Pull output, Open-Drain output. Built-in pull-up resistor, with Schmitt trigger function.

When PB06 and PB07 function as the I2C0 interface, they support level signal communication at different voltages, enabling low-voltage level recognition.

2.8 NVIC

The Cortex-M0+ processor integrates a Nested Vectored Interrupt Controller (NVIC) supporting up to 23 interrupt request (IRQ) inputs. With 4 interrupt priority levels, it can handle complex logic for real-time control and interrupt processing.

2.9 RESET

This product features 6 reset signal sources. Each reset signal can restart the CPU, reset most registers, and point the program counter (PC) to the starting address.

- Digital area power-on and power-off reset POR
- External Reset PAD, low level is reset signal
- IWDG reset
- LVD low voltage reset
- Cortex-M0+ SYSRESETREQ software reset
- Cortex-M0+ LOCKUP hardware reset

2.10 DMAC

The DMAC (Direct Memory Access Controller) function block can transmit data at high speed without passing through the CPU. Using DMAC can improve system performance.

- The DMAC is equipped with an independent bus, so even when the CPU bus is used, the DMAC can also perform transfer operations.
- Composed of 2 channels, capable of performing 2 independent DMA transfers.
- The transmission destination address, transmission source address, transmission data size, transmission request source, and transmission mode can be set, and the transmission operation start of each channel, the forced termination of transmission and the suspension of transmission can be controlled.
- It can control the start, forcibly terminate and pause of batch transmission of all channels.

- When multiple channels are operated at the same time, a fixed method or a cyclic method can be used to select the priority of the operating channel.
- Supports hardware DMA transfer using peripheral interrupt signals.
- Comply with system bus (AHB) and support 32-bit address space (4GB).

2.11 Timer

Name		Width	Prescaler	Count Direction	PWM	Capture	Complementary Output
ATIM3		16/32	1/2/4/8/16/32/64/256	Up count/ Count down/ Up and down count	6	6	3
CTIM0	GTIM0	16	1-32768	Up count	4	4	1
	BTIM0/1/2	16	1-32768	Up count	-	-	1/1/1
CTIM1	GTIM1	16	1-32768	Up count	4	4	1
	BTIM3/4/5	16	1-32768	Up count	-	-	1/1/1
CTRIM		16	2-32768	Up count	-	-	-
LPTIM		16	1-32768	Up count	1	-	1

The composite timer CTIM can be configured as a timer that supports 4-channel comparison capture function, or it can be configured as 3 basic timers. The basic timer is a timer with only timing and counting functions.

Advanced Timer includes timer ATIM3, supporting the following functions:

- PWM independent output, complementary output
- Capture input
- Pulse width measurement
- Quadrature encoder counting function
- Single pulse mode
- External counting function
- DMA trigger
- Dead-time control
- Braking control
- Edge alignment, symmetric center alignment and asymmetric center alignment PWM output

ATIM3 is a multi-channel general-purpose timer, capable of generating 3 sets of complementary PWM outputs or 6 independent PWM channels, with up to 6 input capture channels. With dead zone control function.

The low-power timer LPTIM is an asynchronous 16-bit timer/counter that can continue timing/counting via the internal low-speed RC oscillator, external low-speed crystal oscillator, or ETR external input even after the system clock is turned off. Wake up the system in low-power mode through interrupts. Supports PWM pulse output.

2.12 IWDG

The IWDG is a configurable 12-bit timer that provides a reset in case of MCU malfunction, with the internal RC10K clock input as the counter clock. In debug mode, it can be configured to pause or continue running; the IWDG can only be restarted by writing a specific sequence.

2.13 USART

1-channel Universal Synchronous Asynchronous Receiver/Transmitter.

Basic functions of USART:

- 2 baud rate generation methods: integer frequency division, decimal frequency division
- Built-in multifunctional timer/counter, supporting functions such as receive timeout
- Support DMA continuous communication
- Asynchronous serial port features
 - ▶ Transfer data asynchronously
 - ▶ 2 frame lengths: 8 bits, 9 bits
 - ▶ Frame check: odd check, even check, no check
 - ▶ 2 stop bits: 1 bit, 2 bits
 - ▶ Support hardware flow control (CTS/RTS)
 - ▶ Support single-wire half-duplex communication
 - ▶ Support baud rate automatic detection
 - ▶ Support for multiprocessor communication
- Synchronous serial port features
 - ▶ Transfer data synchronously
 - ▶ The data length is fixed at 8 bits
 - ▶ Support hardware flow control (CTS/RTS)
 - ▶ 2 communication clock sources: internal clock source, external clock source
- Smart card interface features
 - ▶ Communication protocol: ISO/IEC7816-3
 - ▶ 8 ETU lengths: 16-512
 - ▶ Support hardware error detection and retransmission
 - ▶ Support master interface
- Infrared communication features
 - ▶ Support 3/16 no carrier mode
 - ▶ Support 38K carrier modulation mode, adjustable duty cycle, configurable modulation level
- LIN features
 - ▶ Support synchronous interval transmission and detection
 - ▶ Support synchronous segment transmission and baud rate automatic detection

2.14 LPUART

2-channel Low-Power Universal Asynchronous Receiver/Transmitter (LPUART) that can operate in low-power mode.

Basic functions of LPUART:

- Configuration clock PCLK

- Transmission clock SCLK (SCLK can select XTL, RCL and PCLK)
- Support synchronous half-duplex, asynchronous full-duplex and single-wire half-duplex transmission.
- Programmable serial communication function
 - ▶ 2 character lengths: 8 bits, 9 bits
 - ▶ 3 check methods: no check, odd check, even check
 - ▶ 3 stop lengths: 1 bit, 1.5 bits, 2 bits
- Supports transmitting and receiving data in low power mode
- 16-bit baud rate counter
- Support hardware flow control (RTS, CTS)
- Support multi-machine communication and automatic address recognition
- Support data transfer via DMA

2.15 SPI

2-channel Serial Peripheral Interface(SPI).

Basic features of SPI:

- Can be configured as master or slave, support multi-machine mode
- The maximum division factor in master mode is PCLK/2
- The maximum division factor in slave mode is PCLK/4
- Multiple communication modes: full-duplex, single-wire half-duplex, simplex
- 2 transmission orders: MSB first or LSB first
- Various data frame lengths: 4bits-16bits
- 2 NSS methods: hardware control, software control
- Configurable serial clock polarity and phase
- Support DMA
- Support master mode delayed sampling

2.16 I2C

2-channel I2C, using serial synchronous clock, can realize data transmission between devices at different rates.

Basic features of I2C:

- Support 4 working modes of master sending/receiving and slave sending/receiving
- Support 3 operating rates: Standard (100kbps)/Fast (400kbps)/Fast enhanced (1Mbps)
- Support 7-bit addressing function
- Support noise filtering function
- Support 3 slave addresses
- Support broadcast address
- Support interrupt status query function

2.17 CTRIM

In calibration mode, this module automatically performs real-time calibration of the RC48M/RCL output frequency, making RC48M/RCL's accuracy immune to environmental variations. When the module works in timer mode, it has general timing function and can still work normally in DeepSleep mode.

2.18 Electronic Signature

Each chip has a unique 10-byte device identification number before leaving the factory, including wafer lot information, chip coordinate information, and so on.

2.19 TRNG

TRNG is a true random number generator, used to generate true random numbers.

2.20 ADC

A monotonic no missing code 12-bit successive approximation register analog-to-digital converter.

- 12-bit conversion accuracy
- 1Msps conversion speed
- Up to 16 input channels are supported, including 14 external pin inputs, 2 internal input channels (1/3 AVCC voltage, VCAP)
- 2 reference sources: AVCC voltage, EXVREF pins
- ADC voltage input range: 0-Vref
- Support SQR scan conversion
- Software can configure ADC conversion rate
- Support on-chip peripherals to automatically trigger ADC conversion, effectively reducing chip power consumption and improving real-time conversion

2.21 VC

Chip pin voltage monitoring/comparison circuit. Configurable positive/negative input channels: 6 internal/external negative input ports and 8 external positive input ports. Can generate asynchronous interrupts based on rising/falling edges to wake up the MCU from low-power modes. Configurable software anti-stake and window comparison functions. The PWM signal output from ATIM3 can serve as a blanking window signal to control the comparator output.

2.22 LVD

Detects chip supply voltage or pin voltage, supporting the following functions:

- 3 monitoring sources
- 16-stage threshold voltage, 1.8-4.8V optional
- 3 interrupt triggering methods: high level/rising edge/falling edge
- 2 trigger results: reset and interrupt
- 12-stage filter configuration to prevent false triggering
- With hysteresis function, strong anti-interference

2.23 Embedded Debugging System

Embedded debugging solution, providing a full-featured real-time debugger, with standard mature Keil/IAR and other debugging and development softwares.

2.24 Programming Mode

Support programming modes: online programming and offline programming.

Support programming protocols: ISP protocol, SWD protocol.

Support programming interface: ISP protocol and SWD protocol share SWD port.

2.25 High Security

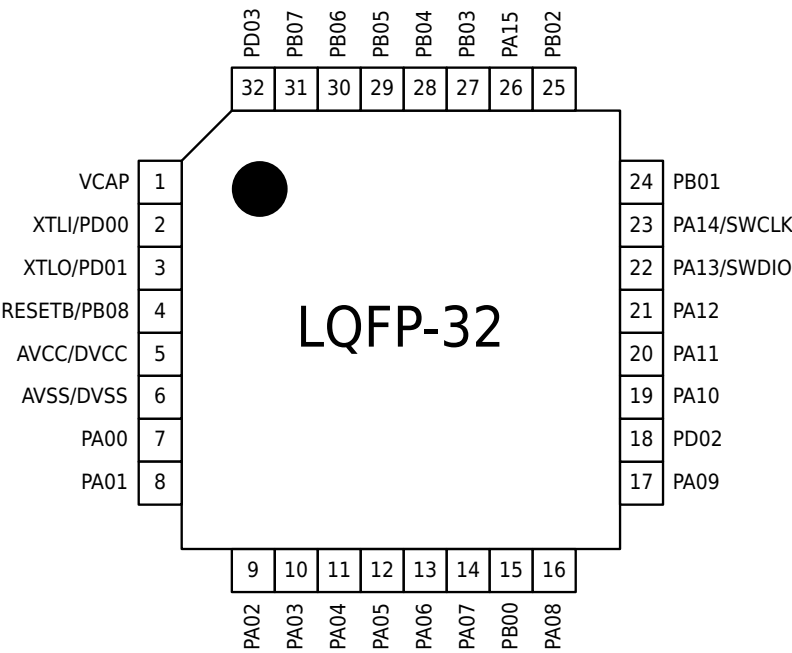
Encrypted embedded debugging solution, providing a full-featured real-time debugger.

3 Pin Definitions

3.1 Pinout

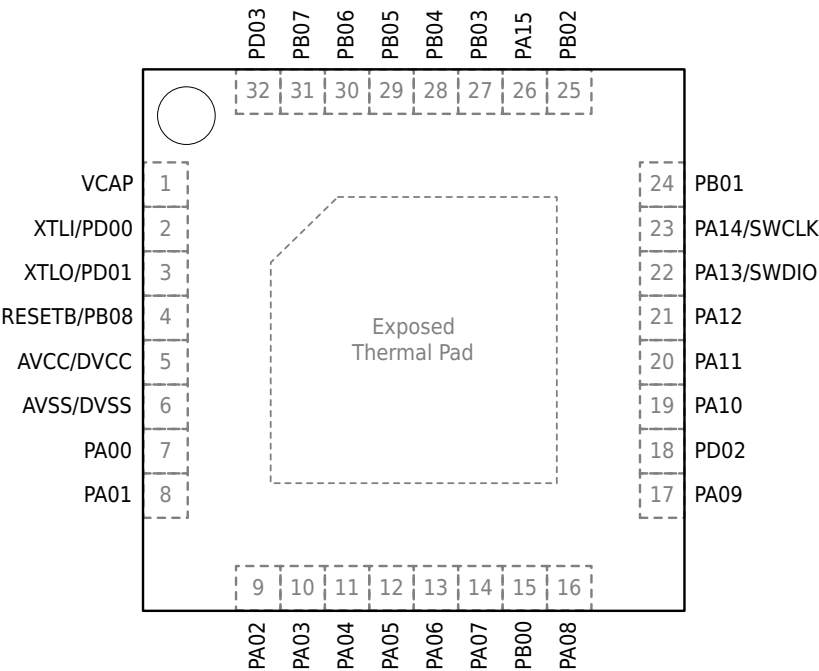
3.1.1 LQFP32 Package

HC32L031F8TB-LQ32



3.1.2 QFN32 Package

HC32L031F8UB-QFN32TR

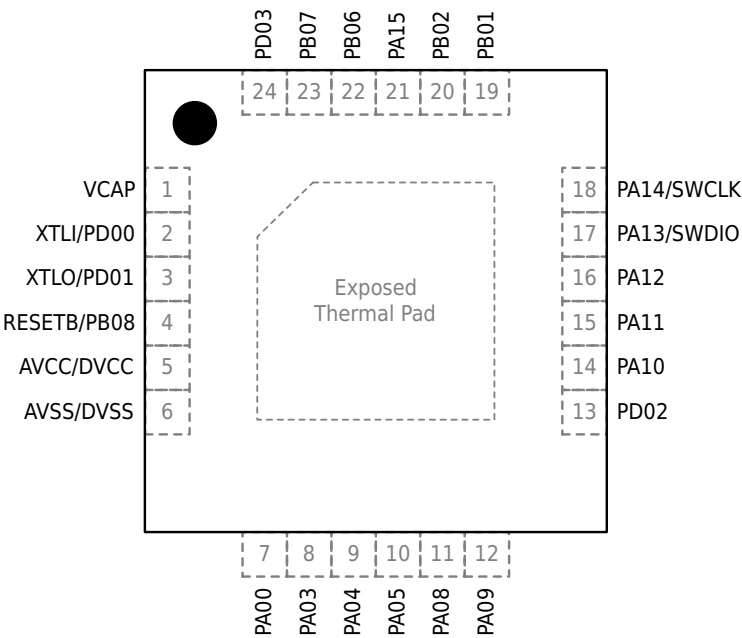


 **Note**

- Exposed Thermal Pad needs to be connected to DVSS.

3.1.3 QFN24 Package

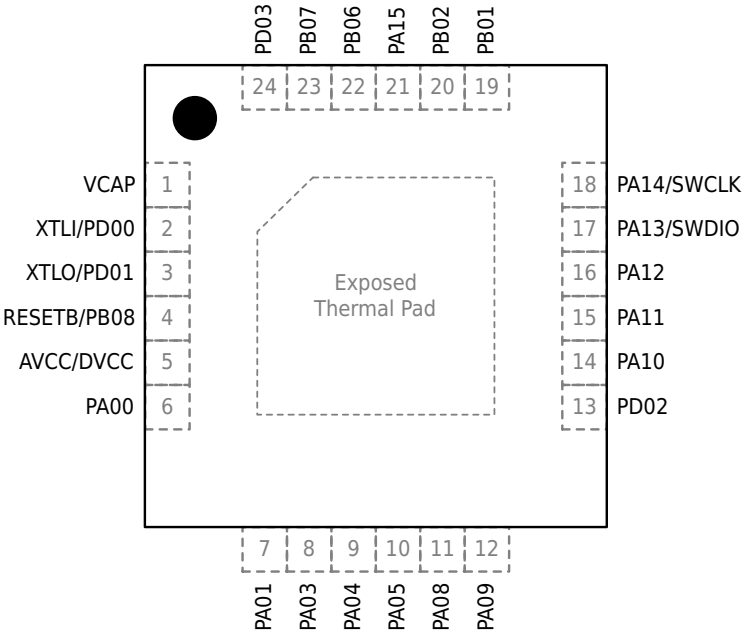
HC32L031D8UB-QFN24TR



 **Note**

- Exposed Thermal Pad needs to be connected to DVSS.

HC32L031D8UB-UFN24TR



 **Note**

- This package has no AVSS/DVSS pins, and the Exposed Thermal Pad must be connected to the system ground.

3.2 Pin Function Description

LQFP32	QFN32	QFN24 (4mm*4mm)	QFN24 (3mm*3mm)	Name	ANALOG
1	1	1	1	VCAP	-
2	2	2	2	PD00/EXTL_IN	XTLI
3	3	3	3	PD01	XTLO
4	4	4	4	RESETB/PB08	-
5	5	5	5	AVCC/DVCC	-
6	6	6	-	AVSS/DVSS	-
7	7	7	6	PA00	AIN1/EXVREF/VC0_INN0/VC0_INP0
8	8	-	7	PA01	AIN0/VC0_INN1/VC0_INP1/VC1_INN0/ VC1_INP0
9	9	-	-	PA02	VC0_INP2/VC1_INN1/VC1_INP1
10	10	8	8	PA03	AIN2/VC0_INP3/VC1_INP2
11	11	9	9	PA04	AIN3/VC0_INN2/VC0_INP4/VC1_INN2/ VC1_INP3
12	12	10	10	PA05	AIN4/VC0_INP5/VC1_INP4
13	13	-	-	PA06	AIN5/VC1_INP5
14	14	-	-	PA07	AIN6
15	15	-	-	PB00	AIN7
16	16	11	11	PA08	AIN8/VC0_INN3/VC0_INP6/VC1_INN3/ VC1_INP6
17	17	12	12	PA09	AIN9
18	18	13	13	PD02	AIN10
19	19	14	14	PA10	AIN11
20	20	15	15	PA11/EXTH_IN	AIN12
21	21	16	16	PA12	AIN13
22	22	17	17	PA13/SWDIO	-
23	23	18	18	PA14/SWCLK	-
24	24	19	19	PB01	LVD_IN1
25	25	20	20	PB02	-
26	26	21	21	PA15	-
27	27	-	-	PB03	-
28	28	-	-	PB04	-
29	29	-	-	PB05	-
30	30	22	22	PB06	-
31	31	23	23	PB07	VC0_INP7/VC1_INP7/LVD_IN2
32	32	24	24	PD03	-

The digital function of each pin is controlled by the PSEL bit field, as detailed in the following table.

Table 3-2 Port Multiplexing Table

AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7
PA00	LPUART0_CTS	SPI1_CS	CTIM0_ETR	LVD_OUT	ATIM3_CH0B	USART_TXD	TCLK_OUT
PA01	LPUART0_TXD	LPUART1_RXD	CTIM0_CH1	LPTIM_ETR	ATIM3_CH0A	USART_RXD	SPI1_MOSI
PA02	LPUART0_RXD	CTIM0_CH2	LPUART1_TXD	ATIM3_CH1A	-	-	SPI1_MISO
PA03	SPI0_CS	CTIM0_TOG	LPUART1_RXD	CTIM1_CH0	ATIM3_BK	ATIM3_CH1B	LPUART0_TXD
PA04	SPI0_MOSI	SPI0_MISO	LPUART1_TXD	CTIM1_CH1	LPUART0_RXD	LPUART0_RTS	ATIM3_CH2A
PA05	SPI0_MISO	SPI0_MOSI	-	CTIM0_CH3	ATIM3_CH2B	VC0_OUT	ATIM3_ETR
PA06	SPI0_SCK	-	-	-	VC1_OUT	ATIM3_GATE	LPUART1_CTS
PA07	-	LPUART1_RTS	-	-	CTIM1_CH2	LPTIM_TOG	I2C1_SDA
PA08	SPI1_MOSI	SPI1_MISO	CTIM1_ETR	ATIM3_ETR	LPUART0_CTS	VC0_OUT	USART_SCK
PA09	SPI1_MISO	SPI1_MOSI	LPUART1_CTS	CTIM1_ETRTOG	RCH_OUT	RCL_OUT	XTL_OUT
PA10	LPUART0_TXD	-	SPI1_MISO	CTIM0_TOGN	LPTIM_GATE	LPUART1_RXD	ATIM3_BK
PA11	LPUART0_RXD	-	CTIM0_TOG	I2C0_SCL	CTIM1_TOGN	RTC_TAMP	LPUART1_TXD
PA12	USART_TXD	ATIM3_CH1A	SPI0_CS	I2C0_SDA	CTIM1_TOG	VC1_OUT	SPI0_SCK
PA13	USART_RTS	LPUART1_RXD	I2C0_SCL	I2C1_SDA	SPI0_MOSI	SPI0_MISO	CTIM1_ETRTOG
PA14	USART_CTS	LPUART1_TXD	I2C0_SDA	I2C1_SCL	SPI0_MISO	SPI0_MOSI	LPTIM_ETR
PA15	-	LPUART0_RXD	-	LPUART1_TXD	CTIM0_CH0	ATIM3_CH0B	USART_SCK
PB00	SPI1_CS	SPI1_SCK	LPUART1_TXD	LPUART0_RXD	RTC_TAMP	LPTIM_TOGN	I2C1_SCL
PB01	USART_RXD	ATIM3_CH2B	SPI0_SCK	ATIM3_ETR	RTC_1HZ	IR_OUT	SPI0_CS
PB02	ATIM3_CH2A	USART_TXD	ATIM3_CH1B	LVD_OUT	LPUART0_RXD	-	LPUART1_TXD
PB03	SPI0_MISO	CTIM0_CH1	CTIM1_CH3	-	ATIM3_CH0A	HCLK_OUT	PCLK_OUT
PB04	SPI0_MOSI	-	-	USART_CTS	CTIM1_TOGN	ATIM3_CH2A	ATIM3_CH1B
PB05	-	-	-	-	LPTIM_GATE	ATIM3_CH1A	USART_RTS
PB06	I2C0_SCL	USART_TXD	CTIM1_CH2	CTIM0_CH2	I2C1_SDA	ATIM3_CH0A	LPTIM_TOG
PB07	I2C0_SDA	USART_RXD	CTIM1_CH3	I2C1_SCL	CTIM0_CH3	LPTIM_TOGN	ATIM3_GATE
PB08	-	-	-	-	-	-	-
PD00	I2C0_SDA	I2C1_SCL	LPUART1_TXD	LPUART0_RXD	-	-	-
PD01	I2C0_SCL	I2C1_SDA	LPUART1_RXD	LPUART0_TXD	-	-	-
PD02	SPI1_SCK	SPI1_CS	LPUART1_RXD	LPUART0_TXD	CTIM1_ETR	RTC_1HZ	LPUART1_RTS

AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7
PD03	-	-	-	-	-	-	-

3.3 Module Signal Description

Table 3-3 Module Signal Description

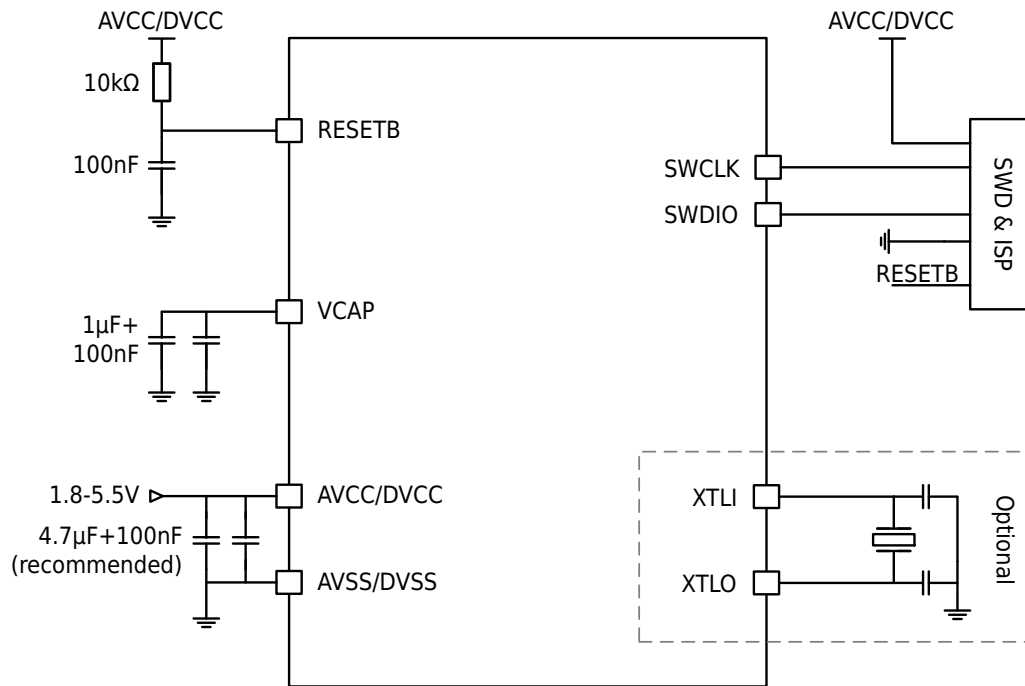
Modules	Pin Name	Description
Power supply	AVCC/DVCC	Power supply
	AVSS/DVSS	Ground
	VCAP	LDO core power supply output (only for internal circuit use, external voltage stabilization capacitor is required)
CLOCK	EXTH_IN	External high-speed clock input
	EXTL_IN	External low-speed clock input
	XTLO	External low-speed clock oscillator interface
	XTLI	External low-speed clock oscillator interface
ADC	AINx (x=0-13)	ADC input channel
	EXVREF	ADC external reference voltage
VC	VCx_INNy (x=0-1 y=0-3)	VC0/1 negative input 0-3
	VCx_INPy (x=0-1 y=0-7)	VC0/1 positive input 0-7
	VCx_OUT (x=0-1)	VC0/1 compare output
LVD	LVD_INx (x=1-2)	Voltage detection input
	LVD_OUT	Voltage detection output
USART	USART_TXD	USART data transmitter
	USART_RXD	USART data receiver
	USART_CTS	USART transmit hardware flow control
	USART_RTS	USART receive hardware flow control
	USART_SCK	USART clock input and output
LPUART	LPUARTx_TXD (x=0-1)	LPUART data transmitter
	LPUARTx_RXD (x=0-1)	LPUART data receiver
	LPUARTx_CTS (x=0-1)	LPUART transmit hardware flow control
	LPUARTx_RTS (x=0-1)	LPUART receive hardware flow control
CTRIM	CTRIM_ETR/TOG	CTRIM external sync signal/inverted output signal
SPI	SPIx_MISO (x=0-1)	SPI master input and slave output data signal
	SPIx_MOSI (x=0-1)	SPI master output and slave input data signal
	SPIx_SCK (x=0-1)	SPI clock signal
	SPIx_CS (x=0-1)	SPI chip selection
I2C	I2Cx_SDA (x=0-1)	I2C data signal
	I2Cx_SCL (x=0-1)	I2C clock signal

Modules	Pin Name	Description
RTC	RTC_1HZ	RTC 1Hz output
	RTC_TAMP	RTC timestamp input
CTIM	CTIMx_CHy (x=0-1 y=0-3)	GTIM capture input comparison output/BTIM inverted output signal
	CTIMx_ETR (x=0-1)	External counting input signal of GTIM
	CTIMx_TOG/TOGN (x=0-1)	Inverted output signal of GTIM/BTIM
ATIM3	ATIM3_CHyA (y=0-2)	Capture input and compare output A of ATIM3
	ATIM3_CHyB (y=0-2)	Capture input and compare output B of ATIM3
	ATIM3_ETR	External counting input signal of ATIM3
	ATIM3_BK	External brake input signal of ATIM3
	ATIM3_GATE	Gating signal of ATIM3
LPTIM	LPTIM_TOG	Toggle/PWM output signal of LPTimer
	LPTIM_TOGN	Toggle/PWM output inverted signal of LPTimer
	LPTIM_ETR	External count input signal of LPTimer
	LPTIM_GATE	Gating signal of LPTimer

**Note**

The IO port is reset to the input high impedance stat, while the port states are maintained in Sleep mode and DeepSleep mode.

4 Typical Application Circuit Diagram



Notice

- Power supply requires external decoupling capacitors. For better anti-interference capability, it is preferable to route the power supply/ground lines through the decoupling capacitors first before connecting them to the chip.
- The crystal and load capacitors should be placed as close as possible to the oscillator pins of the chip.
- The VCAP decoupling capacitor should be placed as close as possible to the chip pin and kept as far away as possible from the crystal load capacitors.

5 Electrical Specifications

5.1 Parameter Conditions

Unless otherwise specified, all voltages are based on VSS.

5.1.1 Minimum and Maximum Values

All Minimum Values and Maximum Values are measured under the worst conditions.

Data resulted from comprehensive evaluation, and/or guaranteed by design are indicated in the table footnotes, and they will not be tested on the production line.

5.1.2 Typical Values

Unless otherwise specified, typical data are given based on $T_A=25^{\circ}\text{C}$ and $V_{CC}=3.3\text{V}$. These data are only used for design guidance and have not been tested.

5.2 Absolute Maximum Ratings

If the load applied to the device exceeds the value given in the list of "Absolute Maximum Ratings", it may cause permanent damage to the device. The maximum load given here is for reference, which does not mean that the functional operation of the device is correct under this condition. Operation of the device under the condition of maximum value for a long time will affect the reliability of the device.

Table 5-1 Voltage and Current Characteristics

Symbol	Parameters	Min	Max	Unit
VCC-VSS	External main supply voltage (including AVCC and DVCC) ⁽¹⁾	-0.3	6.0	V
V _{IN}	Input voltage on other pins ⁽²⁾	VSS-0.3	VCC+0.3	V
ΔVCCx	Voltage difference between different power supply pins	-	50	mV
VSSx-VSS	Voltage difference between different grounding pins	-	50	mV
V _{ESD} (HBM)	Electrostatic discharge voltage (Human model)	Refer to absolute maximum electrical parameters		V
I _{VCC}	Total current through DVCC/AVCC power line (supply current) ⁽¹⁾	-	100	mA
I _{VSS}	Total current through DVSS/AVSS ground wire (outflow current) ⁽¹⁾	-	100	mA
I _{IO}	Output sink current on any I/O and control pins	-	25	mA
	Output current on any I/O and control pins	-	-25	mA
I _{INJ(PIN)} ⁽²⁾⁽³⁾	Injection current of RESETB pin	-	±5	mA
	Injection current of the XTLL pin in XTL	-	±5	mA
	Injection current of other pins ⁽⁴⁾	-	±5	mA
ΣI _{INJ(PIN)} ⁽²⁾	Total injection current on all I/O and control pin ⁽⁴⁾	-	±25	mA

**Note**

1. All powers (DVCC, AVCC) and grounding (DVSS, AVSS) pins should always be connected to the power supply system within the external allowable range.
2. $I_{INJ(PIN)}$ should not exceed its limit, that is, ensure that V_{IN} does not exceed its maximum value. If V_{IN} cannot be guaranteed not to exceed its maximum value, it is also necessary to ensure that $I_{INJ(PIN)}$ does not exceed its maximum value externally. When $V_{IN} > VCC$, there is a forward injection current; When $V_{IN} < VSS$, there is a reverse injection current.
3. The reverse injection current will interfere with the simulation performance of the device.
4. When several I/O ports have injection currents at the same time, the maximum value of $\sum I_{INJ(PIN)}$ is the sum of the instantaneous absolute values of the forward injection current and the reverse injection current. This result is based on the features of the maximum value of $\sum I_{INJ(PIN)}$ at four I/O ports of the device.
5. The input voltage of IO with analog input channel of ADC should be between VSS and VCC; otherwise, the conversion accuracy of ADC will be affected.

Table 5-2 Temperature Characteristics

Symbol	Parameters	Value	Unit
T_{STG}	Storage temperature range	-65-+150	°C
T_{Jmax}	Maximum junction temperature	125	°C

5.3 Operating Conditions

5.3.1 General Operating Conditions

Table 5-3 General Operating Conditions

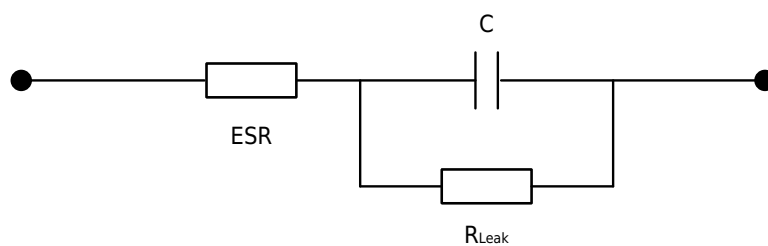
Symbol	Parameters	Conditions	Min	Max	Unit
f_{HCLK}	Internal AHB clock frequency	-	0	48	MHz
f_{PCLK0}	Internal APB0 clock frequency	-	0	48	MHz
f_{PCLK1}	Internal APB1 clock frequency	-	0	48	MHz
DVCC/ AVCC	Operating voltage ⁽¹⁾	-	1.8	5.5	V
T_A	Ambient temperature ⁽²⁾	-	-40	105	°C
T_J	Junction temperature range	-	-40	125	°C

**Note**

1. When using an ADC, see ADC Electrical Specifications.
2. $T_A(max)$ applies to $P_D(max)$. When $P_D < P_D(max)$, ambient temperature T_A may exceed $T_A(max)$ provided the junction temperature T_J does not exceed T_{Jmax} . For detailed specifications, refer to the [Packaging Thermal Resistance Coefficient](#).

5.3.2 VCAP External Capacitor

The stability of the main voltage regulator is achieved by connecting an external capacitor C_{EXT} to the VCAP pin. The specified values for C_{EXT} are detailed in the table below.

Figure 5-1 External Capacitor C_{EXT} **Note**

ESR stands for equivalent series resistance.

Table 5-4 VCAP Working Conditions

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$C_{EXT}^{(1)}$	External capacitance value	-	1	-	4.7	μF
ESR	External capacitor ESR	-	-	-	100	m Ω
VCAP ⁽¹⁾	LDO supply voltage	-	1.52	1.60	1.68	V

**Note**

1. Resulted from comprehensive evaluation, not tested in production.

5.3.3 Working Conditions at Power-On and Power-Down

Table 5-5 Working Conditions at Power-On and Power-Down⁽¹⁾

Symbol	Parameters	Conditions	Min	Max	Unit
S_{VCC_r}	VCC Rise Rate	-	0	1	V/ μs
S_{VCC_f}	VCC Fall Rate	-	0	0.05	V/ μs

**Note**

1. Resulted from comprehensive evaluation, not tested in production.

5.3.4 Embedded Reset and LVD Module Characteristics

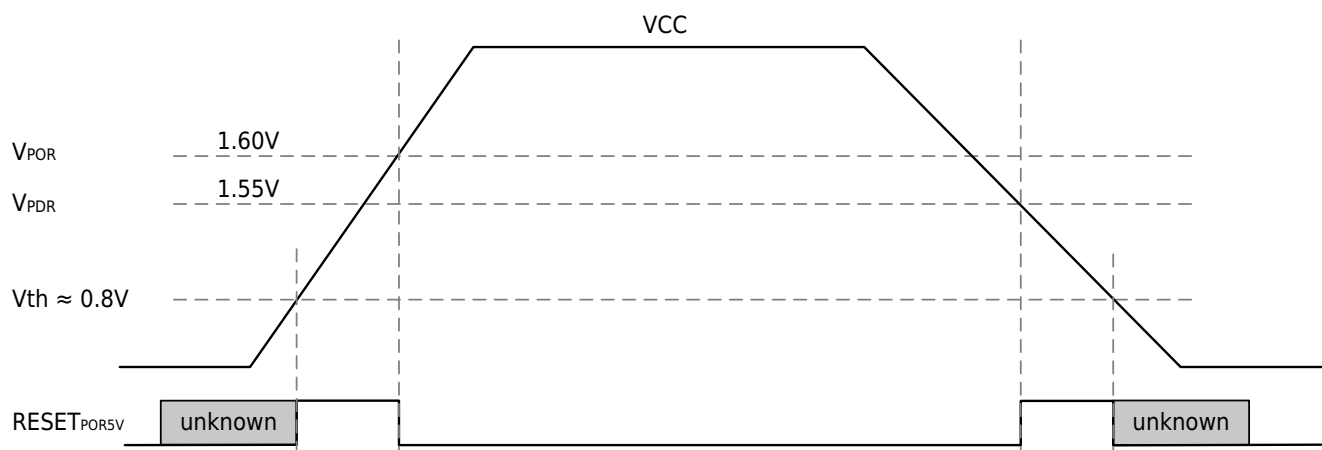


Figure 5-2 POR/PDR Schematic Diagram

Table 5-6 POR/PDR

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
V _{POR}	POR release voltage (power on process)	-	1.50	1.60	1.70	V
V _{PDR}	PDR detection voltage (power down process)	-	1.40	1.55	1.65	V

Table 5-7 LVD Module Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
V _{ex}	External input voltage range	-	0	-	VCC	V
V _{level} ⁽¹⁾	Detection threshold	LVD_CR.VTDS=0b0000	1.70	1.80	1.90	V
		LVD_CR.VTDS=0b0001	1.90	2.00	2.10	V
		LVD_CR.VTDS=0b0010	2.10	2.20	2.30	V
		LVD_CR.VTDS=0b0011	2.30	2.40	2.50	V
		LVD_CR.VTDS=0b0100	2.50	2.60	2.70	V
		LVD_CR.VTDS=0b0101	2.70	2.80	2.90	V
		LVD_CR.VTDS=0b0110	2.90	3.00	3.10	V
		LVD_CR.VTDS=0b0111	3.10	3.20	3.30	V
		LVD_CR.VTDS=0b1000	3.30	3.40	3.50	V
		LVD_CR.VTDS=0b1001	3.45	3.60	3.75	V
		LVD_CR.VTDS=0b1010	3.65	3.80	3.95	V
		LVD_CR.VTDS=0b1011	3.85	4.00	4.15	V
		LVD_CR.VTDS=0b1100	4.05	4.20	4.35	V
		LVD_CR.VTDS=0b1101	4.25	4.40	4.55	V
		LVD_CR.VTDS=0b1110	4.45	4.60	4.75	V
		LVD_CR.VTDS=0b1111	4.65	4.80	4.95	V
I _{comp}	Power Consumption	-	-	0.20	-	μA
T _{response}	Response Time	Choose to detect the GPIO pin voltage, VCC=3.3V, LVD_CR.VTDS= 0b1000, the detection voltage changes from (V _{level} +100mV) to (V _{level} -100mV), and the change slope is $2 \times 10^5 V/\mu s$	-	90	-	μs
T _{setup}	Settling time	Choose to detect the GPIO pin voltage, VCC=3.3V, LVD_CR.VTDS= 0b1000, the detection voltage is lower than V _{level} 100mV	-	400	-	μs
V _{hys}	Hysteresis voltage	-	-	60	-	mV
T _{filter}	Filter time	LVD_CR.DEBOUNCE_TIME=0b0000	-	0	-	μs
		LVD_CR.DEBOUNCE_TIME=0b0001	-	2*T _{LVD}	-	μs

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
T_{filter}	Filter time	LVD_CR.DEBOUNCE_TIME=0b0010	-	$4 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b0011	-	$8 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b0100	-	$16 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b0101	-	$32 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b0110	-	$64 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b0111	-	$128 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1000	-	$256 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1001	-	$512 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1010	-	$1024 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1011	-	$2048 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1100	-	$4096 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1101	-	$4096 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1110	-	$4096 \cdot T_{\text{LVD}}$	-	μs
		LVD_CR.DEBOUNCE_TIME=0b1111	-	$4096 \cdot T_{\text{LVD}}$	-	μs

**Note**

1. Resulted from comprehensive evaluation, not tested in production.
2. T_{LVD} represents the filter clock period, with the filter clock operating at approximately 256kHz.

5.3.5 Supply Current Characteristics

Current consumption is a comprehensive index of multiple parameters and factors. These parameters and factors include operating voltage, ambient temperature, I/O pin load, product software configuration, operating frequency, I/O pin flip rate, and the location of the program in memory and the executed code, etc.

The MCU is in the following conditions:

- All I/O pins are in input mode and connected to a static level-VCC or VSS (no load).
- All peripherals are turned off, unless otherwise specified.
- The access time of the flash memory is adjusted to the frequency f_{HCLK} (0 wait cycle for 0-24MHz, 1 wait cycle for 24-48MHz)

Table 5-8 Operating Current Characteristics⁽³⁾

Symbol	Parameters	Conditions	Typ ⁽¹⁾	Max ⁽²⁾		Unit
				25°C	85°C	
I_{DD} (Run in RAM)	All peripherals clock ON, Run while(1) in RAM	RC48M clock source	4M	405	-	μA
			6M	532	-	μA
			32M	2202	-	μA
			48M	3245	-	μA
	All peripherals clock OFF, Run while(1) in RAM	RC48M clock source	4M	303	-	μA
			6M	379	-	μA
			32M	1400	-	μA

Symbol	Parameters	Conditions		Typ ⁽¹⁾	Max ⁽²⁾		Unit
				25°C	85°C	105°C	
I _{DD} (Run in RAM)	All peripherals clock OFF, Run while(1) in RAM		48M	2010	-	-	μA
I _{DD} (Run CoreMark)	All peripherals clock OFF, Run CoreMark in Flash	RC48M clock source	4M	574	-	-	μA
			6M	738	-	-	μA
			32M	1758	-	-	μA
			48M	2473	-	-	μA
I _{DD} (Run mode)	All peripherals clock ON, Run while(1) in Flash	RC48M clock source	4M	712	TBD	TBD	μA
			6M	985	TBD	TBD	μA
			32M	2364	TBD	TBD	μA
			48M	3378	TBD	TBD	μA
	All peripherals clock OFF, Run while(1) in Flash	RC48M clock source	4M	610	TBD	TBD	μA
			6M	832	TBD	TBD	μA
			32M	1556	TBD	TBD	μA
			48M	2140	TBD	TBD	μA
I _{DD} (Sleep mode)	All peripherals clock ON	RC48M clock source	4M	335	TBD	TBD	μA
			6M	426	TBD	TBD	μA
			32M	1638	TBD	TBD	μA
			48M	2387	TBD	TBD	μA
	All peripherals clock OFF	RC48M clock source	4M	232	TBD	TBD	μA
			6M	272	TBD	TBD	μA
			32M	827	TBD	TBD	μA
			48M	1148	TBD	TBD	μA
I _{DD} (LP Run)	All peripherals clock ON, Run while(1) in Flash	32K clock source	RCL32K ⁽⁴⁾	80	TBD	TBD	μA
			XTL32K, Driver=2	76	TBD	TBD	μA
	All peripherals clock OFF, Run while(1) in Flash	32K clock source	RCL32K ⁽⁴⁾	79	TBD	TBD	μA
			XTL32K, Driver=2	75	TBD	TBD	μA
I _{DD} (LP Sleep)	All peripherals clock ON,	32K clock source	RCL32K ⁽⁴⁾	77	TBD	TBD	μA
			XTL32K, Driver=2	75	TBD	TBD	μA
	All peripherals clock OFF,	32K clock source	RCL32K ⁽⁴⁾	76	TBD	TBD	μA
			XTL32K, Driver=2	75	TBD	TBD	μA
I _{DD} (Deep-Sleep)	All peripherals clock OFF	NO CLK		0.65	TBD	TBD	μA
		RCL32K ⁽⁴⁾		0.92	TBD	TBD	μA
		XTL32K		1.39	TBD	TBD	μA
	Other peripherals clock OFF	RCL32K+IWD ⁽⁴⁾		1.02	TBD	TBD	μA
		RCL32K+LVD ⁽⁴⁾		1.06	TBD	TBD	μA
		RCL32K+IWD ⁽⁴⁾ +LVD ⁽⁴⁾		1.19	TBD	TBD	μA

**Note**

1. Unless otherwise specified, typical values are measured at $V_{CC}=3.3V$ and $V_{CAP}=1.6V$.
2. Unless otherwise specified, maximum values are measured across the full operating voltage range of V_{CC} with $V_{CAP}=1.6V$.
3. Resulted from comprehensive evaluation, not tested in production.
4. This data was measured under the condition of RCL@LPM. The typical value data in HPM mode is approximately $0.4\mu A$ higher than that in LPM mode.

5.3.6 Time to Wake-Up from Low-Power Mode

The wake-up time is measured during the wake-up phase of the RC48M oscillator. The clock source used when waking up depends on the current operating mode:

- Sleep mode: clock source is RC48M oscillator
- DeepSleep mode: clock source is RC48M oscillator

Table 5-9 Low-Power Mode Wake-Up Time

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$T_{wu}^{(1)}$	Sleep mode wake-up time	-	-	1.8	-	μs
	DeepSleep mode wake-up time	$F_{RC48M}=4MHz$	-	20.0	-	μs
		$F_{RC48M}=6MHz$	-	20.0	-	μs
		$F_{RC48M}=32MHz$	-	15.0	-	μs
		$F_{RC48M}=48MHz$	-	15.0	-	μs

**Note**

1. Guaranteed by design, not tested in production.
2. The wake-up time is measured from the start of the wake-up event to the user program reading the first instruction.

5.3.7 External Clock Source Characteristics

5.3.7.1 External Input High-Speed Clock

Table 5-10 External Input High-Speed Clock Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
f_{EXTH}	User external clock frequency	-	4	8	24	MHz
V_{EXTHH}	Input pin high level voltage	-	$0.7V_{CC}$	-	V_{CC}	V
V_{EXTHL}	Input pin low level voltage	-	V_{SS}	-	$0.3V_{CC}$	V
$T_{r(EXTH)}$	Rising time	-	-	-	20	ns
$T_{f(EXTH)}$	Falling time	-	-	-	20	ns
$T_{w(EXTH)}$	Enter high or low time	-	16	-	-	ns
$C_{in(EXTH)}$	Input capacitance	-	-	5	-	pF

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
Duty	Duty cycle	-	40	-	60	%
I_L	Input leakage current	-	-	-	± 1	μA

**Note**

1. Guaranteed by design, not tested in production.

5.3.7.2 External Input Low-Speed Clock

Table 5-11 External Input Low-Speed Clock⁽¹⁾

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
f_{EXTL}	User external clock frequency	-	0	32.768	1000	kHz
V_{EXTLH}	Input pin high level voltage	-	0.7VCC	-	VCC	V
V_{EXTLL}	Input pin low level voltage	-	VSS	-	0.3VCC	V
$T_{r(EXTL)}$	Rising time	-	-	-	50	ns
$T_{f(EXTL)}$	Falling time	-	-	-	50	ns
$T_{w(EXTL)}$	Enter high or low time	-	450	-	-	ns
$C_{in(EXTL)}$	Input capacitance	-	-	5	-	pF
Duty	Duty cycle	-	30	-	70	%
I_L	Input leakage current	-	-	-	± 1	μA

**Note**

1. Guaranteed by design, not tested in production.

5.3.7.3 External Low-Speed Crystal XTL

The external low-speed crystal (XTL) can be generated using a 32.768kHz crystal/ceramic resonator oscillator. The information given in this section is based on typical external components and the results obtained through comprehensive characteristic evaluation. In the application, the resonator and load capacitor must be as close as possible to the oscillator pin to reduce output distortion and settling time at startup. For detailed parameters (frequency, package, accuracy, etc.) of the crystal resonator, please consult the corresponding manufacturer.

Table 5-12 External Low-Speed Crystal XTL Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
F_{CLK}	Oscillator frequency	-	-	32.768	-	kHz
ESR_{CLK}	Supported crystal ESR range	-	-	-	60	k Ω
$C_{Lx}^{(2)}$	Matching capacitance	Configure as required by the crystal manufacturer.	4	12	20	pF
DC_{ACLK}	Duty Cycle	-	30	50	70	%

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$I_{dd}^{(3)}$	Electrorheograph	XTL_CR[3:0]=0b1111	-	1330	-	nA
		XTL_CR[3:0]=0b1011	-	1230	-	
		XTL_CR[3:0]=0b0111	-	1140	-	
		XTL_CR[3:0]=0b0011	-	1050	-	
		XTL_CR[3:0]=0b1110	-	630	-	
		XTL_CR[3:0]=0b1010	-	580	-	
		XTL_CR[3:0]=0b0110	-	530	-	
		XTL_CR[3:0]=0b0010	-	490	-	
		XTL_CR[3:0]=0b1101	-	400	-	
		XTL_CR[3:0]=0b1001(Recommended value)	-	370	-	
		XTL_CR[3:0]=0b0101	-	350	-	
		XTL_CR[3:0]=0b0001	-	310	-	
		XTL_CR[3:0]=0b1100	-	290	-	
		XTL_CR[3:0]=0b1000	-	270	-	
		XTL_CR[3:0]=0b0100	-	250	-	
		XTL_CR[3:0]=0b0000	-	230	-	
g_m	Transconductance	XTL_CR[3:0]=0b1111	-	14.64	-	μS
		XTL_CR[3:0]=0b1011	-	13.17	-	
		XTL_CR[3:0]=0b0111	-	11.67	-	
		XTL_CR[3:0]=0b0011	-	10.15	-	
		XTL_CR[3:0]=0b1110	-	7.37	-	
		XTL_CR[3:0]=0b1010	-	6.62	-	
		XTL_CR[3:0]=0b0110	-	5.87	-	
		XTL_CR[3:0]=0b0010	-	5.10	-	
		XTL_CR[3:0]=0b1101	-	4.94	-	
		XTL_CR[3:0]=0b1001(Recommended value)	-	4.44	-	
		XTL_CR[3:0]=0b0101	-	3.93	-	
		XTL_CR[3:0]=0b0001	-	3.41	-	
		XTL_CR[3:0]=0b1100	-	3.72	-	
		XTL_CR[3:0]=0b1000	-	3.34	-	
		XTL_CR[3:0]=0b0100	-	2.95	-	
		XTL_CR[3:0]=0b0000	-	2.57	-	
$T_{start}^{(4)}$	Start time	ESR=30k Ω C_{Lx} =12pF XTL_CR[3:0]=0b1010	-	2000	-	ms

**Note**

1. Resulted from comprehensive evaluation, not tested in production.
2. C_{Lx} refers to the two pin matching capacitors C_{L1} and C_{L2} of the crystal. It is recommended to use high-quality ceramic capacitors, and select a crystal or resonator that meets the requirements. Usually C_{L1} and C_{L2} have the same parameters. When selecting C_{Lx} , one should take into account parameters such as the crystal oscillator's frequency and ESR, as well as the total parasitic capacitance to ground (C_p) from the PCB and MCU pins.

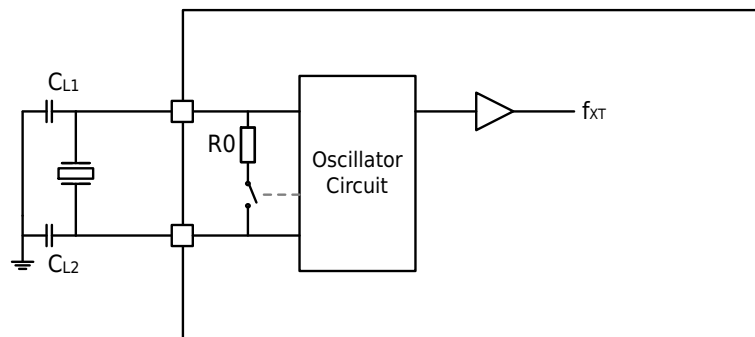
The C_{Lx} is recommended to be configured in accordance with the requirements of the crystal manufacturer's technical manual.

- If the crystal manufacturer gives *the value of the load capacitance* (C_L), the matching capacitance $C_{Lx} = 2 * C_L - C_p$.
- If the crystal manufacturer gives *the value of the matching capacitance*, the matching capacitance $C_{Lx} = \text{matching capacitance value} - C_p$.

In practical applications, if a larger C_{Lx} is selected, it is recommended to choose an appropriate current level setting.

Example:

- When the crystal manufacturer gives the load capacitance of the crystal as 8pF, considering the distributed capacitance between the PCB and MCU pins, it is recommended to choose a matching capacitor with a capacitance of 12pF.
 - When the crystal manufacturer gives the matching capacitance of the crystal as 12pF, considering the distributed capacitance between the PCB and MCU pins, it is recommended to choose a matching capacitor with a capacitance of 10pF or 8pF.
3. Choose a high-quality oscillator with a small ESR value, and you can optimize the current consumption by adjusting the `SYSCTRL_XTLCR[3:0]` setting value. Current consumption is proportional to the transconductance (g_m) provided by the circuit.
 4. T_{start} is the start-up time, which is the time from the software enabling XTL to start measuring until a stable 32768Hz oscillation is obtained. This value is measured using a standard crystal resonator with the settings `SYSCTRL_XTLCR[3:0]=0b1001` and `SYSCTRL_XTLCR[5:4]=0b10`. It may vary greatly depending on the crystal manufacturer and model.

**Note**

- The feedback resistance R_0 has been integrated in the chip.

5.3.8 Internal Clock Source Characteristics

5.3.8.1 RC48M

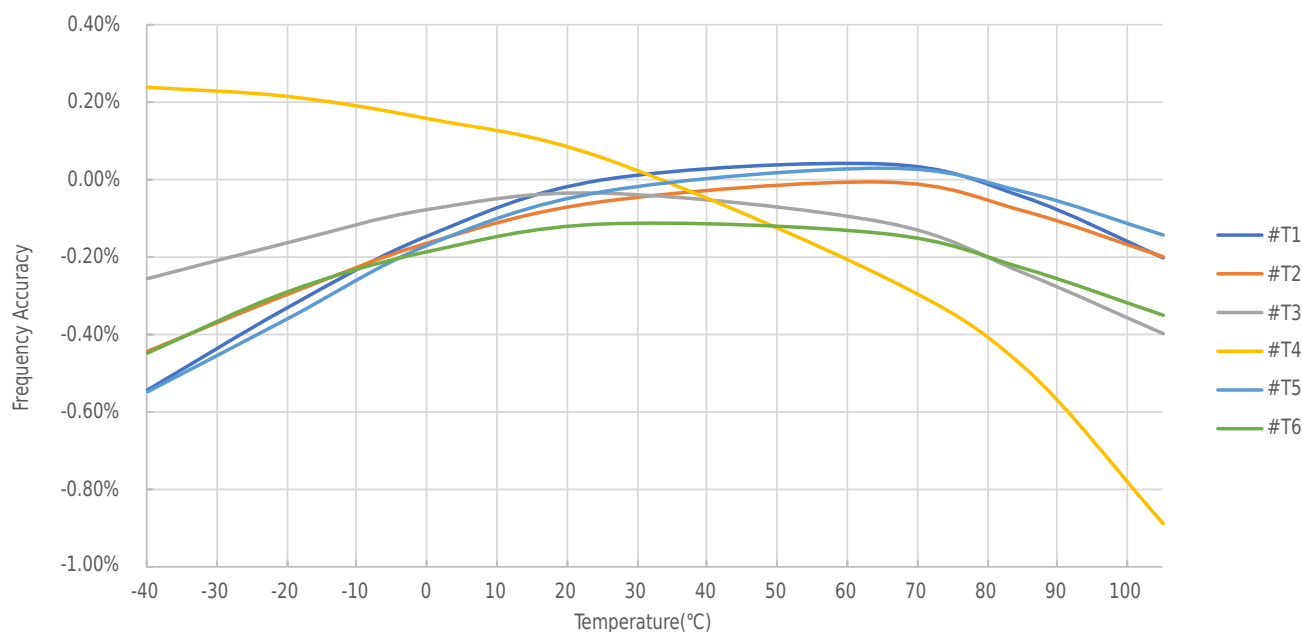
Table 5-13 Internal High-Speed Clock RC48M Oscillator Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
F_{CLK}	Oscillator frequency	RC48M_CR.FSEL=0x0	-	4.0	-	MHz
		RC48M_CR.FSEL=0x1	-	6.0	-	MHz
		RC48M_CR.FSEL=0x2	-	32.0	-	MHz
		RC48M_CR.FSEL=0x3	-	48.0	-	MHz
TRIM ⁽¹⁾	User-adjustable frequency step size	-	-	0.12	-	%
ACC ⁽¹⁾	Oscillation frequency accuracy range at different temperatures (the reference is typical frequency value)	$V_{CC}=3.3V$ $T_A=25^{\circ}C$	-0.3	-	0.3	%
		$V_{CC}=3.3V$ $T_A=-40-105^{\circ}C$	-1.5	-	1.5	%
ΔV_{CC} ⁽¹⁾	Oscillation frequency drift with V_{CC} (the reference is $V_{CC}=3.3V$)	$V_{CC}=1.8-5.5V$ $T_A=25^{\circ}C$	-0.1	-	0.1	%
I_{CLK} ⁽¹⁾	Power consumption	$F_{CLK}=4MHz$	-	60	-	μA
		$F_{CLK}=6MHz$	-	66	-	μA
		$F_{CLK}=32MHz$	-	177	-	μA
		$F_{CLK}=48MHz$	-	222	-	μA
DC_{CLK} ⁽²⁾	Duty cycle	-	45	50	55	%
t_{su} ⁽²⁾	Startup time (from enable to clock output initiation)	$F_{CLK}=4MHz$	-	8.8	20.1	μs
		$F_{CLK}=6MHz$	-	8.5	19.8	μs
		$F_{CLK}=32MHz$	-	4.7	12.9	μs
		$F_{CLK}=48MHz$	-	4.7	12.8	μs



Note

1. Resulted from comprehensive evaluation, not tested in production.
2. Guaranteed by design, not tested in production.

Figure 5-4 RC48M Clock Frequency Variation Curve ($F_{CLK}=48MHz$, $V_{CC}=3.3V$)

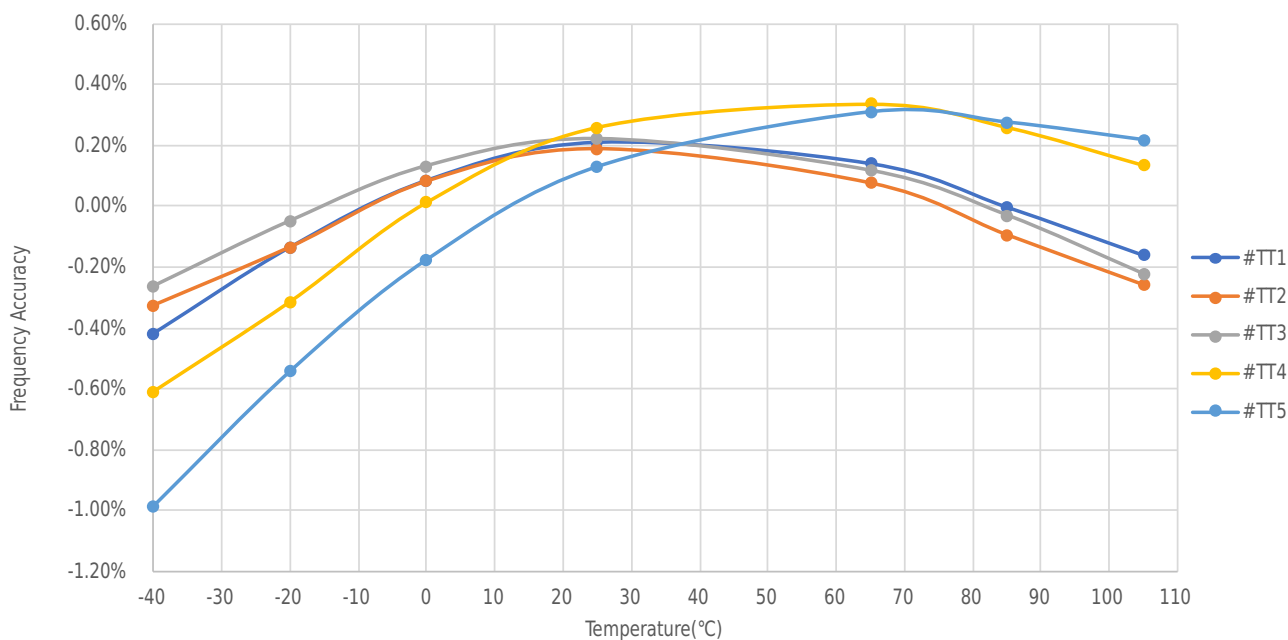
5.3.8.2 RCL

Table 5-14 Internal Low-Speed Clock RCL Oscillator Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
F_{CLK}	Oscillator frequency	$V_{CC}=3.3V$ $T_A=25^{\circ}C$	38.2 32.5	38.4 32.768	38.6 33	kHz
TRIM ⁽¹⁾	User-adjustable frequency step size	-	-	0.5	-	%
Acc ⁽¹⁾⁽²⁾	Oscillation frequency accuracy range at different temperatures (the reference is typical frequency value)	HPM Mode $V_{CC}=1.8-5.5V$ $T_A=-40-105^{\circ}C$	-2.5	-	2.5	%
		LPM Mode $V_{CC}=1.8-5.5V$ $T_A=-40-105^{\circ}C$	-15	-	15	%
$\Delta V_{CC}^{(1)}$	Oscillation frequency drift with V_{CC} (the reference is $V_{CC}=3.3V$)	$V_{CC}=1.8-5.5V$ $T_A=25^{\circ}C$	-0.1	-	0.1	%
T_{CLK}	Start time	-	-	150	-	μs
$DC_{CLK}^{(1)}$	Duty Cycle	-	25	50	75	%

**Note**

1. Resulted from comprehensive evaluation, not tested in production.
2. The HPM or LPM mode can be selected through register configuration. For detailed information, please refer to the "RCL Control Register (RCL_CR)" register of "System Controller (SYSCTRL)" chapter in the "Reference Manual".

Figure 5-5 RCL@HPM Mode Clock Frequency Variation Curve ($F_{CLK}=32.768kHz$, $V_{CC}=3.3V$)

5.3.8.3 RC10K

Table 5-15 Internal Low-Speed Clock RC10K Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
Dev ⁽¹⁾	Oscillator accuracy	$V_{CC}=1.8-5.5V$ $T_A=-40-105^{\circ}C$	-50	-	50	%
F_{CLK}	Oscillator frequency	$V_{CC}<3.3V$ $T_A=25^{\circ}C$	-	10	-	kHz



Note

1. Resulted from comprehensive evaluation, not tested in production.

5.3.8.4 RC256K

Table 5-16 Internal Low-Speed Clock RC256K Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
F_{CLK}	Oscillator frequency	$V_{CC}=3.3V$ $T_A=25^{\circ}C$	-	256	-	kHz
Dev ⁽¹⁾	RCL oscillator accuracy	$V_{CC}=1.8-5.5V$ $T_A=-40-105^{\circ}C$	-5.5	-	5.5	%
DC _{CLK} ⁽¹⁾	Duty cycle	-	40	-	60	%



Note

1. Resulted from comprehensive evaluation, not tested in production.

5.3.9 Flash Memory Characteristics

Table 5-17 Flash Memory Characteristics

Symbol	Parameters	Conditions		Min	Typ	Max	Unit
EC_{FLASH}	Program, Sector Erase times	$T_A = -40^{\circ}C$ $-105^{\circ}C$	Data Storage Period (RET_{FLASH}): 20 years, $T_A = 85^{\circ}C$	-	20000	-	time s
T_{b_prog}	Programming time (bytes)	-		22	-	30	μs
T_{w_prog}	Programming time (words)	-		40	-	52	μs
T_{p_erase}	Page erase time	-		2	-	3	ms
T_{m_erase}	Full chip erase time	-		30	-	40	ms

5.3.10 EMC Characteristics

5.3.10.1 EFT Characteristics

A chip reset can restore the system to normal operation.

Table 5-18 EFT Characteristics

Symbol	Level/Type
EFT to IO (IEC61000-4-4)	TBD
EFT to Power (IEC61000-4-4)	TBD

Design Reliable Software to Mitigate Noise-Related Issues

EMC evaluation and optimization at the device level is conducted in typical application environments (this testing was performed through sampling during comprehensive assessments using official evaluation boards). It should be noted that good EMC performance is closely related to user applications and specific software implementations.

Therefore, it is recommended that users implement EMC optimization in their software and conduct relevant EMC certification testing.

Software Recommendations

The software process must include control to deal with program runaway, such as:

- Corrupted program counter
- Unexpected reset
- Critical data is destroyed (control registers, etc.)

During the EFT test, interference that exceeds the application requirements can be directly applied to the chip power supply or IO. When an unexpected action is detected, the software part is strengthened to prevent unrecoverable errors.

5.3.10.2 ESD Characteristics

Using specific measurement methods, the chip is subjected to strength testing to determine its electrical sensitivity performance.

Table 5-19 ESD Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$VESD_{HBM}^{(1)}$	ESD @ Human Body Mode	$T_A=25^{\circ}C$, in line with ANSI/ESDA/JEDEC JS-001	-4	-	4	kV
$VESD_{CDM}^{(1)}$	ESD @ Charge Device Mode	$T_A=25^{\circ}C$, in line with ANSI/ESDA/JEDEC JS-002	-2	-	2	kV
$I_{latchup}^{(1)}$	Latch up current	$T_A=105^{\circ}C$, in line with JESD78	TBD	-	TBD	mA

**Note**

1. Resulted from comprehensive evaluation, not tested in production.

5.3.11 I/O Port Characteristics

5.3.11.1 Output Characteristics-Port

Table 5-20 Port Output Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Max	Unit
V_{OH}	IO pin output high level	$I_{IO}=6mA$, $VCC=3.3V$	$VCC-0.3$	-	V
		$I_{IO}=12mA$, $VCC=3.3V$	$VCC-0.7$	-	V
V_{OL}	IO pin output low level	$I_{IO}=8mA$, $VCC=3.3V$	-	$VSS+0.3$	V
		$I_{IO}=16mA$, $VCC=3.3V$	-	$VSS+0.7$	V

**Note**

1. Resulted from comprehensive evaluation, not tested in production.
2. The device's I_{IO} current must always comply with the absolute maximum ratings specified in the [Table 5-1 : Voltage and Current Characteristics](#), and the sum of I_{IO} (I_{OH} and I_{OL} of I/O ports) must not exceed I_{VCC} .

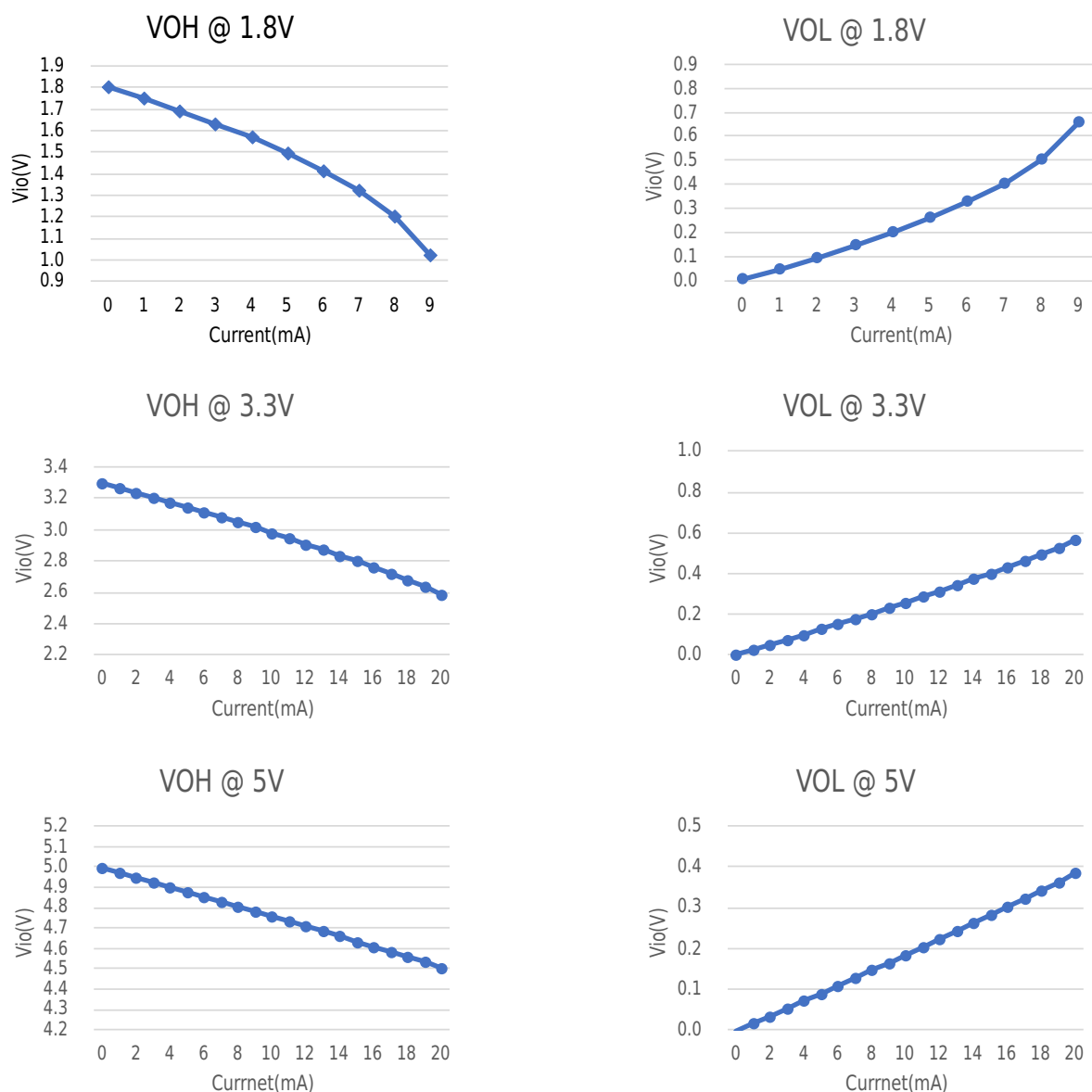


Figure 5-6 Output Port VOH/VOL Measured Curve (Typical Value)

5.3.11.2 Input Characteristics-PA/PB Port

Table 5-21 PA/PB Port Input Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$V_{IH}^{(1)}$	Input high-level voltage	VCC=1.8V	0.7VCC	-	-	V
		VCC=3.3V	0.7VCC	-	-	V
		VCC=5.5V	0.7VCC	-	-	V
$V_{IL}^{(1)}$	Input low-level voltage	VCC=1.8V	-	-	0.3VCC	V
		VCC=3.3V	-	-	0.3VCC	V
		VCC=5.5V	-	-	0.3VCC	V

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
V_{hys}	Input voltage hysteresis($V_{\text{IH}}-V_{\text{IL}}$)	VCC=1.8V	-	0.3	-	V
		VCC=3.3V	-	0.4	-	V
		VCC=5.5V	-	0.6	-	V
R_{pullhigh}	Weak pull-up equivalent resistance	Weak pull-up enable VCC=3.3V	-	60	-	k Ω
C_{input}	Input equivalent capacitance	-	-	5	-	pF

**Note**

1. Resulted from comprehensive evaluation, not tested in production.

Table 5-22 PB06/PB07 Input Level Low Voltage Recognition Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
V_{IH}	Input high-level voltage ⁽²⁾	-	0.7V _{CC}	-	-	V
V_{IL}	Input low-level voltage ⁽²⁾	-	-	-	0.3V _{CC}	V

**Note**

1. Guaranteed by design, not tested in production.
2. This level recognition feature is exclusively used for I2C communication and is unrelated to the input characteristics of GPIO ports.

5.3.11.3 Port Leakage Characteristics- PA/PB Port**Table 5-23 PA/PB Port Leakage Characteristics**

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$I_{\text{lk}}(\text{Px.y})$	Leakage current	$V_{(\text{Px.y})}^{(1)(2)}$	-	± 50	-	nA

**Note**

1. The port leakage is based on the corresponding port being connected to VSS or VCC.
2. The port must be configured as an input port.

5.3.12 RESETB Pin Characteristics

The RESETB pin input driver uses CMOS technology, which is connected with a pull-up resistor that cannot be disconnected.

Table 5-24 RESETB Pin Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
$V_{\text{IL}}(\text{RESETB})^{(1)}$	Input low-level voltage	-	-0.3	-	0.3V _{CC}	V
$V_{\text{IH}}(\text{RESETB})^{(1)}$	Input high-level voltage	-	0.7V _{CC}	-	V _{CC} +0.3	V
$V_{\text{hys}}(\text{RESETB})$	Schmitt trigger voltage hysteresis	-	-	400	-	mV

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
R_{PU}	Weak pull-up equivalent resistance	$V_{IN}=V_{SS}$	-	60	-	$k\Omega$
$T_{F(RESETB)}^{(1)}$	Filtered input pulse	-	-	-	1	μs
$T_{NF(RESETB)}^{(1)}$	Non-filtered input pulse	-	5	-	-	μs

**Note**

1. Guaranteed by design, not tested in production.

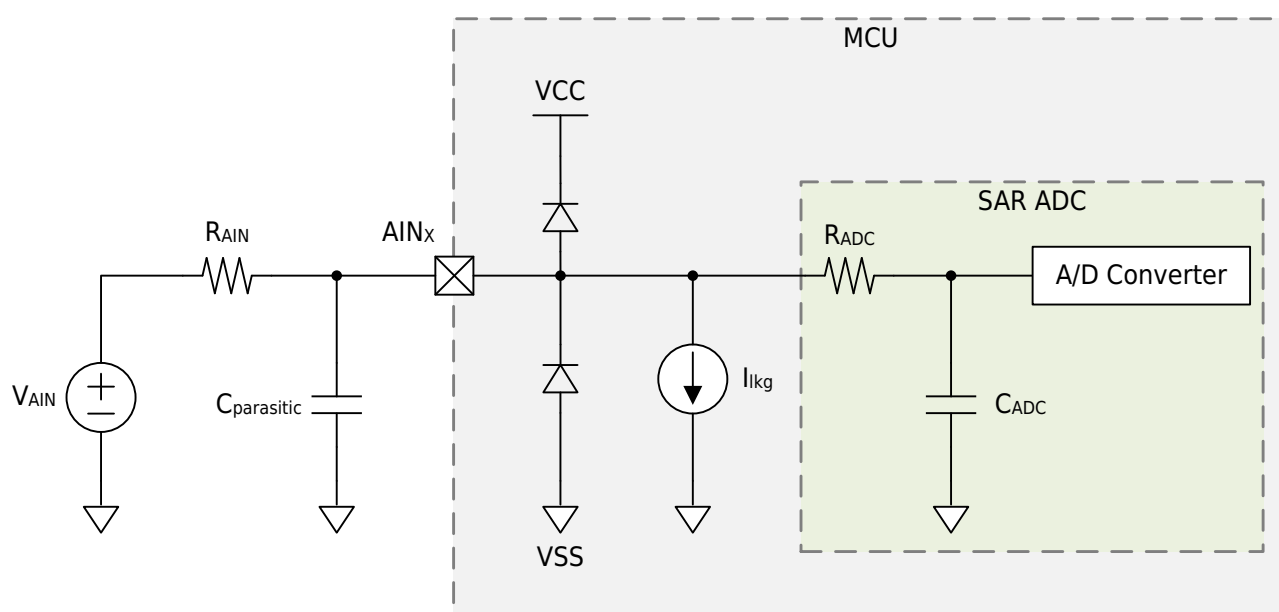
5.3.13 ADC Characteristics

Table 5-25 ADC Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
AVCC	Analog supply voltage	-	1.8	3.3	5.5	V
V_{AIN}	ADC input voltage range	Single-ended input mode	0	-	V_{REF+}	V
$V_{REF+}^{(1)}$	Positive reference voltage	-	1.5	-	AVCC	V
V_{REF-}	Negative reference voltage	-	-	AVSS	-	V
$DEV_{AVCC/3}^{(2)}$	AVCC/3 accuracy	-	-3	± 2	3	%
$I_{ADC}^{(1)}$	Operating current consumption	$f_s=1\text{Msps}$ $T_s=4/f_{ADCCLK}$	-	0.31	-	mA
$C_{ADC}^{(1)}$	ADC internal sampling capacitor	-	-	5	-	pF
$R_{ADC}^{(1)}$	ADC internal sampling resistor	-	-	1.5	-	$k\Omega$
$R_{AIN}^{(1)(4)}$	ADC external input impedance	-	-	-	1.5	$k\Omega$
$f_{ADCCLK}^{(1)}$	ADC clock frequency	$2.7V \leq AVCC \leq 5.5V$	0.3	-	24	MHz
		$2.4V \leq AVCC < 2.7V$	0.3	-	8	
		$1.8V \leq AVCC < 2.4V$	0.3	-	4	
$f_s^{(1)}$	Sampling rate	$2.7V \leq AVCC \leq 5.5V$	0.02	-	1	Msps
		$2.4V \leq AVCC < 2.7V$	0.02	-	0.5	
		$1.8V \leq AVCC < 2.4V$	0.02	-	0.25	
$T_{ADCSTART}$	Start time	-	-	-	10	μs
$T_s^{(3)}$	Sample time	-	2	4	127	$1/f_{ADCCLK}$
$T_{ADCCONV}$	Total conversion time (Including sampling time)	-	-	T_s+12	-	μs
$ENOB^{(2)}$	Effective bits	$2.7V \leq AVCC \leq 5.5V$	9.8	10.4	-	bits
$SNR^{(2)}$	signal to noise ratio	$f_s=1\text{Msps}$	60.0	64.8	-	dB

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
THD ⁽²⁾	Total Harmonic Distortion		-	-78.7	-71.5	dB
E _D ⁽²⁾	Differential non-linearity error		-1.0	-0.9/1.9	2.0	LSB
E _L ⁽²⁾	Integral non-linearity error		-4.0	-2.9/1.8	4.0	LSB
E _O ⁽²⁾	Offset Error		-	-1.0/10.1	-	LSB
E _G ⁽²⁾	Gain error		-	-1.7/3.0	-	LSB
E _T ⁽²⁾	Total unadjustable error		-	±11.0	-	LSB

1. Guaranteed by design, not tested in production.
2. Resulted from comprehensive evaluation, not tested in production.
3. The typical application of ADC is shown in the figure below:



In the diagram, I_{lkg} represents the I/O port leakage current. Refer to "[Port Leakage Characteristics-PA/PB Port](#)" for detailed parameters.

Under the condition of 0.5LSB sampling error accuracy requirement, the calculation formula of sampling time is as follows:

$$T_S = \frac{M}{f_{ADCLK}} \geq (R_{AIN} + R_{ADC}) \times C_{ADC} \times (N + 1) \times \ln(2)$$

Where N is the ADC resolution (12 bits), f_{ADCLK} is the ADC clock frequency (f_{PCLK} divided by the prescaler set in register ADC_CR0.CLKDIV), and M is the number of sampling cycles (sampling time occupies M ADC clock cycles, see register ADC_CR0.SAM for specific values).

The table below shows the relationship between ADC minimum sampling time T_S and external resistor R_{AIN} under typical operating conditions ($M=4$, with 0.5LSB sampling error). For other special external input impedance values, the corresponding minimum sampling time requirements can also be calculated through the sampling time calculation formula given above.

Table 5-26 Relationship Between ADC Minimum Sampling Time and External Resistance R_{AIN}

$R_{AIN} (\Omega)$	Minimum Sampling Time T_s (ns)
10	68.0
47	69.7
68	70.6
100	72.1
150	74.3
220	77.5
330	82.4
470	88.8
680	98.2
1000	112.6
1500	135.2
2200	166.7
3300	216.3
4700	279.3
6800	374.0
10000	518.1
15000	743.4

For the above typical applications, you should pay attention to:

- Minimize parasitic capacitance $C_{parasitic}$ at the ADC input port AIN_x , to make sure $C_{parasitic} \ll (1 + R_{ADC}/R_{AIN}) * C_{ADC}$. Otherwise, it may result in insufficient settling of the ADC input voltage and introduce conversion errors.
 - In addition to consider R_{AIN} value, if the internal resistance of signal source V_{AIN} is large, it also needs to be considered.
4. Based on evaluation at $T_j = 125^\circ\text{C}$, the error caused by leakage current must not exceed ± 2 LSB. This limit may be relaxed for lower temperatures. In practical applications, determining the maximum allowable external input impedance requires joint consideration of leakage current and sampling time (refer to the description above).

5.3.14 VC Characteristics

Table 5-27 VC Characteristics

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
V_{in}	Input voltage range	-	0	-	5.5	V
V_{com}	Input common mode range	-	0.2	-	$V_{CC}-0.2$	V
V_{offset}	Input offset	AVCC=3.3 V, $T_A=25^\circ\text{C}$	BIAS=0b00	± 15	-	mV
			BIAS=0b01	± 15	-	mV
			BIAS=0b10	± 10	-	mV

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
V_{offset}	Input offset	BIAS=0b11	-	±5	-	mV
		AVCC=1.8-5.5V, T_A =-40-105°C	BIAS=0b00	±20	-	mV
			BIAS=0b01	±20	-	mV
			BIAS=0b10	±15	-	mV
			BIAS=0b11	±10	-	mV
I_{comp}	Comparator's current	VCx_CR0.BIAS=0b00 VCx_CR0.BIAS=0b01 VCx_CR0.BIAS=0b10 VCx_CR0.BIAS=0b11	-	0.3 1.2 10 20	-	μA
T_{response}	Comparator's response time when one input cross another	VCx_CR0.BIAS=0b00 VCx_CR0.BIAS=0b01 VCx_CR0.BIAS=0b10 VCx_CR0.BIAS=0b11	-	2500 1000 400 200	-	ns
T_{setup}	Comparator's setup time when ENABLE. Input signals unchanged.	VCx_CR0.BIAS=0b00 VCx_CR0.BIAS=0b01 VCx_CR0.BIAS=0b10 VCx_CR0.BIAS=0b11	-	10 2.5 0.7 0.35	-	μs
$V_{\text{hysteresis}}$	Comparator's hysteresis voltage	VCx_CR0.HYS=0b00 VCx_CR0.HYS=0b01 VCx_CR0.HYS=0b10 VCx_CR0.HYS=0b11	-	0 10 20 30	-	mV
$R_{\text{in}}^{(1)}$	allowable source resistance of the input signal	-	-	-	100	kΩ
$V_{\text{error_DAC}}$	Voltage error of DAC in VC	-	-	±25	-	mV
$T_{\text{setup_DAC}}$	Setup time of DAC in VC	-	-	25	-	μs
T_{filter}	Digital filter time	VCx_CR1.FLTTIME=0b000	-	0	-	μs
		VCx_CR1.FLTTIME=0b001	-	$2 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b010	-	$4 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b011	-	$8 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b100	-	$16 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b101	-	$32 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b110	-	$64 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b111	-	$128 \cdot T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1000	-	$256 \cdot T_{\text{VCx}}$	-	μs

Symbol	Parameters	Conditions	Min	Typ	Max	Unit
T_{filter}	Digital filter time	VCx_CR1.FLTTIME=0b1001	-	$512 * T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1010	-	$1024 * T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1011	-	$2048 * T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1100	-	$4096 * T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1101	-	$4096 * T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1110	-	$4096 * T_{\text{VCx}}$	-	μs
		VCx_CR1.FLTTIME=0b1111	-	$4096 * T_{\text{VCx}}$	-	μs

**Note**

1. Guaranteed by design, not tested in production.
2. T_{VCx} represents the filter clock period, with VCx_CR1.FLTCLK selecting either the built-in RC oscillator (about 256kHz) or PCLK as the filter clock.

5.3.15 Timer Characteristics

For details on the characteristics of the input and output multiplex function pins (output compare, input capture, external clock, PWM output), see the table below.

Table 5-28 Advanced Timer (ATIM3) Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Max	Unit
t_{res}	Timer resolution time	-	1	-	t_{TIMCLK}
		$f_{\text{TIMCLK}}=48\text{MHz}$	20.8	-	ns
f_{ext}	External clock frequency	$f_{\text{TIMCLK}}=48\text{MHz}$	0	24	MHz
Res_{Tim}	Timer resolution	-	-	16	Bit
T_{counter}	When the internal clock is selected, the 16-bit counter clock cycle	-	1	65536	t_{TIMCLK}
		$f_{\text{TIMCLK}}=48\text{MHz}$	20.8	1365000	ns

**Note**

1. Guaranteed by design, not tested in production.

Table 5-29 Composite Timer (CTIM) Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Max	Unit
t_{res}	Timer resolution time	-	1	-	t_{TIMCLK}
		$f_{\text{TIMCLK}}=48\text{MHz}$	20.8	-	ns
f_{ext}	External clock frequency	$f_{\text{TIMCLK}}=48\text{MHz}$	0	24	MHz
Res_{Tim}	Timer resolution	-	-	16	Bit

Symbol	Parameters	Conditions	Min	Max	Unit
T_{counter}	When the internal clock is selected, the 16-bit counter	-	1	65536	t_{TIMCLK}
		$f_{\text{TIMCLK}}=48\text{MHz}$	20.8	1365000	ns

**Note**

1. Guaranteed by design, not tested in production.

Table 5-30 Low-Power Timer Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Max	Unit
t_{res}	Timer resolution time	-	1	-	t_{TIMCLK}
		$f_{\text{TIMCLK}}=48\text{MHz}$	20.8	-	ns
f_{ext}	External clock frequency	$f_{\text{TIMCLK}}=48\text{MHz}$	0	24	MHz
Res_{Tim}	Timer resolution	-	-	16	Bit
T_{counter}	When the internal clock is selected, the 16-bit counter clock cycle	-	1	65536	t_{TIMCLK}
		$f_{\text{TIMCLK}}=48\text{MHz}$	20.8	1365000	ns

**Note**

1. Guaranteed by design, not tested in production.

Table 5-31 IWDTC Characteristics⁽¹⁾

Symbol	Parameters	Conditions	Min	Max	Unit
t_{res}	IWDTC overflow time	$f_{\text{IWDTCCLK}}=10\text{kHz}$	0.4	209715.2	ms

**Note**

1. Guaranteed by design, not tested in production.

5.3.16 Communication Interface

5.3.16.1 I2C Characteristics

I2C interface features are as follows:

Table 5-32 I2C Interface Characteristics⁽¹⁾

Symbol	Parameters	Standard Mode (100k)		Fast Mode (400k)		Fast enhanced Mode (1M)		Unit
		Min	Max	Min	Max	Min	Max	
t_{LOW}	SCL clock low time	4.7	-	1.25	-	0.5	-	μs
t_{HIGH}	SCL clock high time	4.0	-	0.6	-	0.26	-	μs
$t_{SU.DAT}$	Data setup time	250	-	100	-	50	-	ns
$t_{HD.DAT}$	Data hold time	0	-	0	-	0	-	μs
$t_{HD.STA}$	(Repeated) START condition hold time	2.5	-	0.625	-	0.25	-	μs
$t_{SU.STA}$	Repeated START condition setup time	2.5	-	0.6	-	0.25	-	μs
$t_{SU.STO}$	STOP condition setup time	0.25	-	0.25	-	0.25	-	μs
t_{BUF}	Bus Idle (STOP condition to START condition)	4.7	-	1.3	-	0.5	-	μs



Note

1. Guaranteed by design, not tested in production.

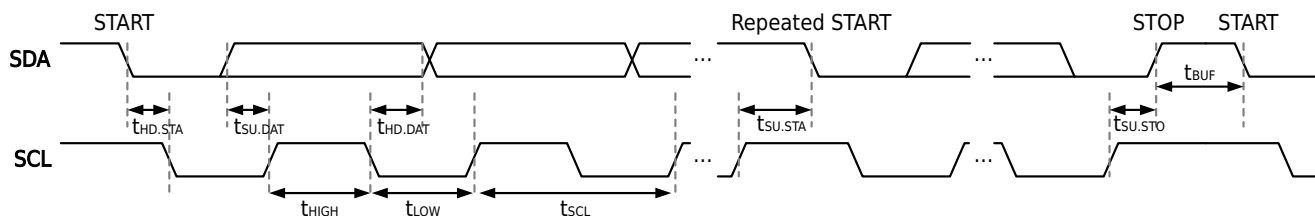


Figure 5-8 I2C Interface Timing

5.3.16.2 SPI Characteristics

Table 5-33 SPI Interface Characteristics⁽¹⁾⁽²⁾

Symbol	Parameters	Conditions	Min	Max	Unit
$t_{c(SCK)}$	Serial clock period ⁽³⁾	Master transmit mode $f_{PCLK}=48MHz$	41.6	-	ns
		Master receiving mode (Master delayed sampling disabled) $f_{PCLK}=48MHz$	166	-	ns
		Master receiving mode (Master delayed sampling enabled) $f_{PCLK}=48MHz$	83.3	-	ns
		Slave transmit mode (Master delayed sampling disabled) $f_{PCLK}=48MHz$	166	-	ns
		Slave transmit mode (Master delayed sampling enabled) $f_{PCLK}=48MHz$	83.3	-	ns
		Slave receiving mode $f_{PCLK}=48MHz$	83.3	-	ns
$t_{w(SCKH)}$	High level time of serial clock	Master mode	$0.45 \times t_{c(SCK)}$	-	ns
		Slave mode	$0.45 \times t_{c(SCK)}$	-	ns
$t_{w(SCKL)}$	Low level time of serial clock	Master mode	$0.45 \times t_{c(SCK)}$	-	ns
		Slave mode	$0.45 \times t_{c(SCK)}$	-	ns
$t_{su(SSN)}$	Setup time selected by slave	Slave Mode	$0.45 \times t_{c(SCK)}$	-	ns
$t_{h(SSN)}$	Hold time selected by slave	Slave Mode	$0.45 \times t_{c(SCK)}$	-	ns
$t_{v(MO)}$	Effective time of master data output	-	-	3	ns
$t_{h(MO)}$	Hold time of master data output	-	0	-	ns
$t_{v(SO)}$	Effective time of slave data output	-	-	$20 + 1.5 \times T_{PCLK}$	ns
$t_{h(SO)}$	Hold time of slave data output	-	$14 + 0.5 \times T_{PCLK}$	-	ns
$t_{su(MI)}$	Setup time of master data input	-	20	-	ns
$t_{h(MI)}$	Hold time of master data input	-	2	-	ns
$t_{su(SI)}$	Setup time of slave data input	-	0	-	ns

Symbol	Parameters	Conditions	Min	Max	Unit
$t_{h(SI)}$	Hold time of slave data input	-	$2+1.5 \times T_{PCLK}$	-	ns

**Note**

1. Guaranteed by design, not tested in production.
2. The data is provided under the condition of $V_{CC}=3.0V$.
3. The maximum frequency division factor of the master mode is $PCLK/2$, and the The maximum frequency division factor of slave mode is $PCLK/4$.

The waveform and timing parameters of the SPI interface signal are as follows:

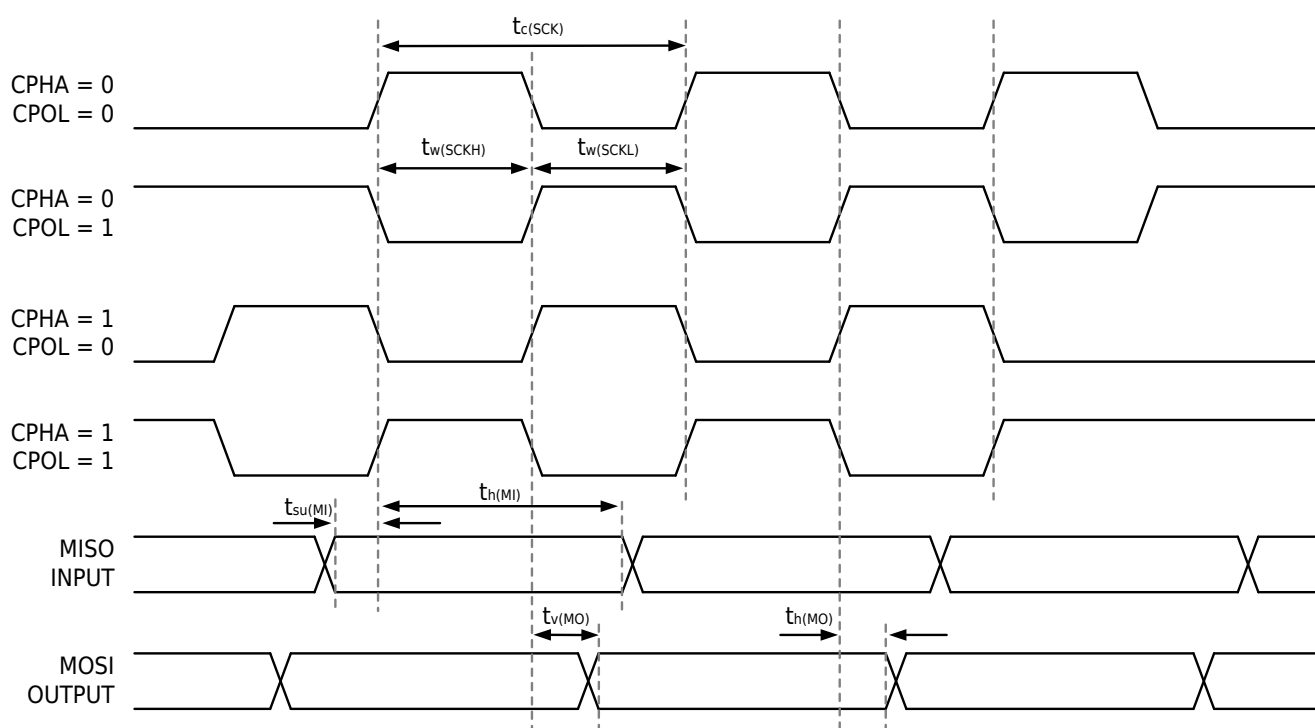


Figure 5-9 SPI Timing Diagram (Master Mode)

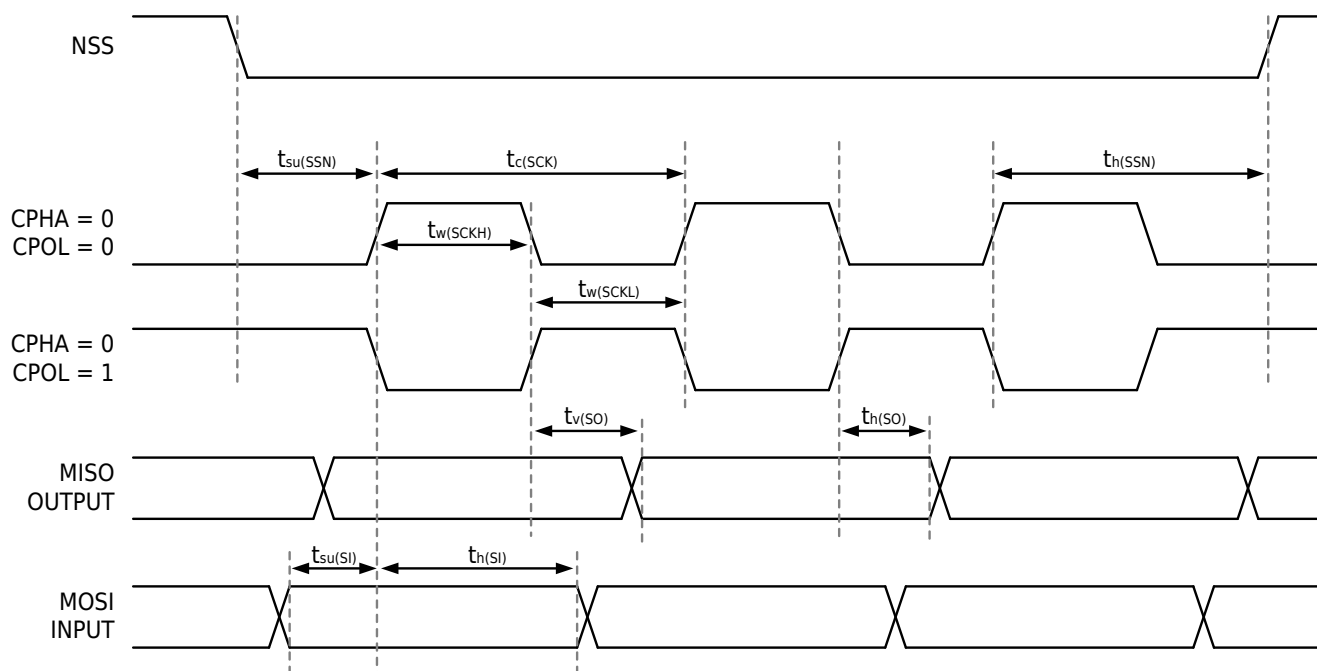


Figure 5-10 SPI Timing Diagram (Slave Mode CPHA=0)

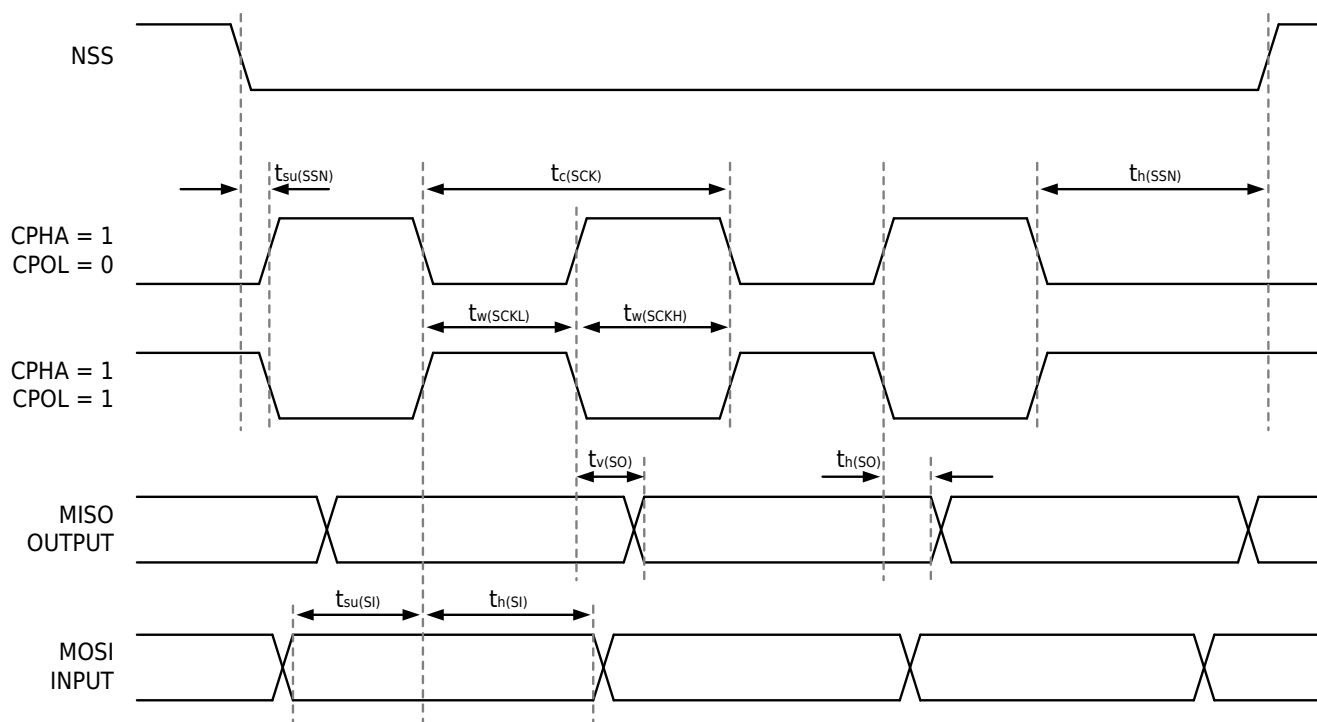
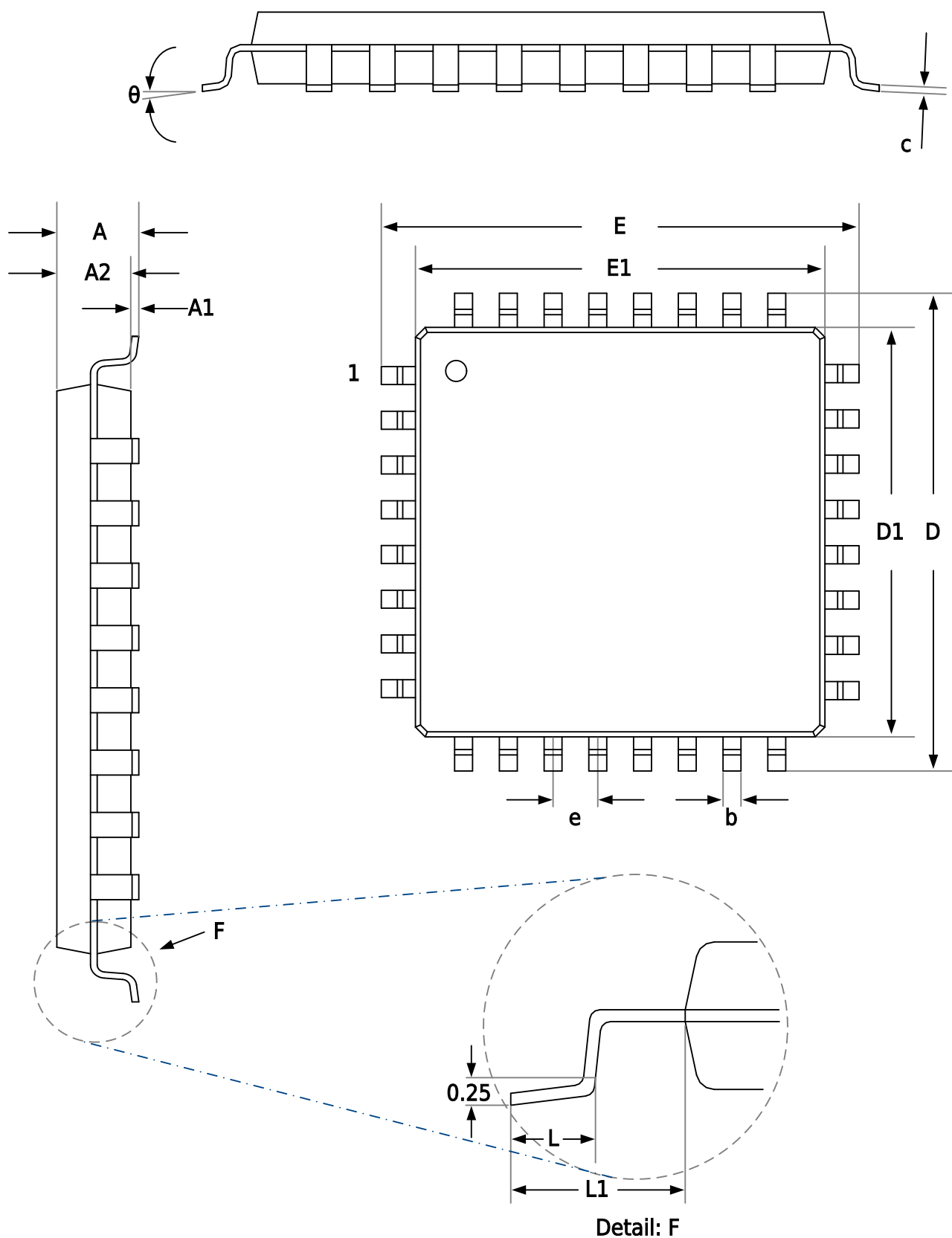


Figure 5-11 SPI Timing Diagram (Slave Mode CPHA=1)

6 Package Specifications

6.1 Package Dimensions

6.1.1 LQFP32 Package

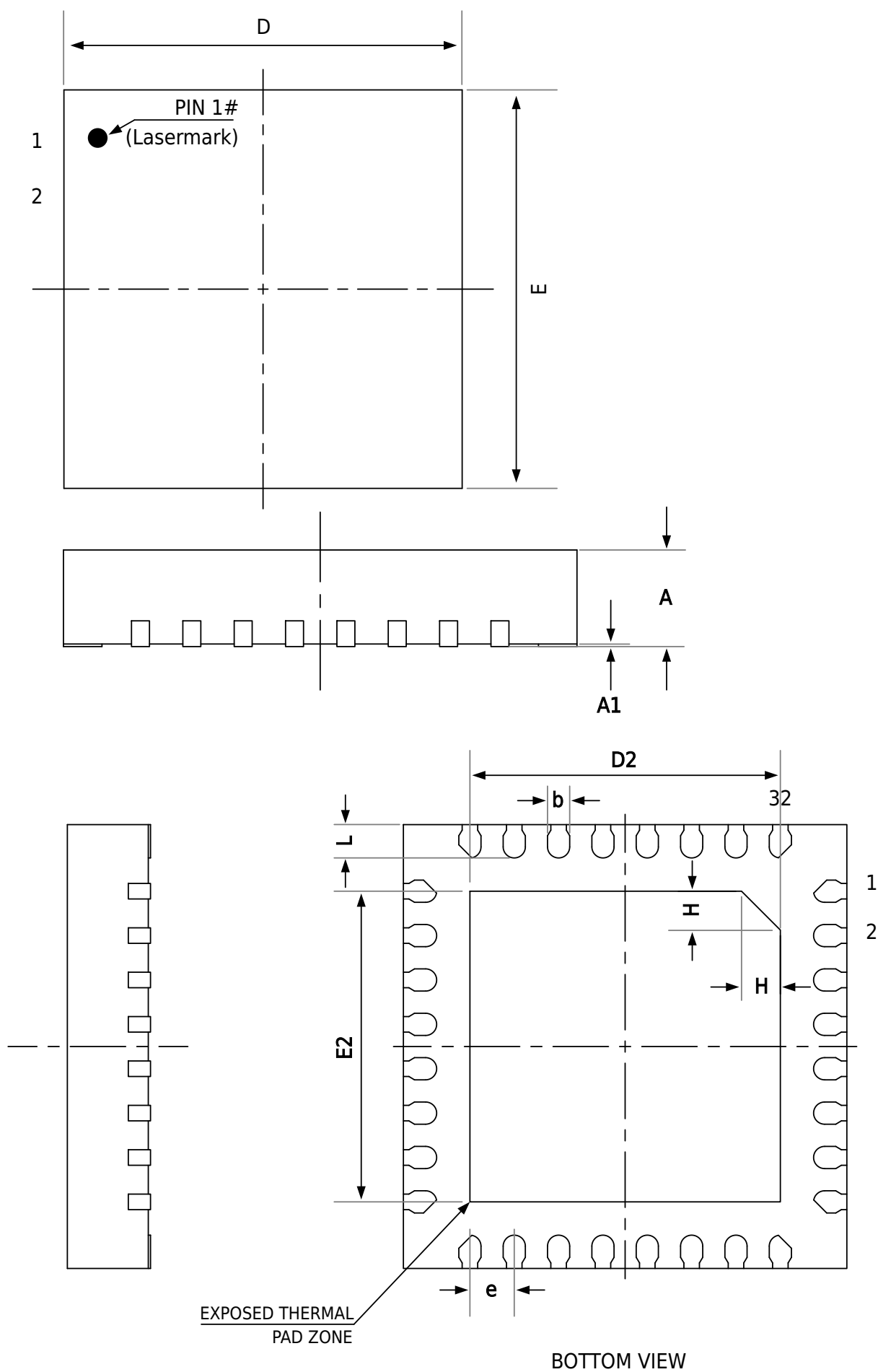


Symbol	7*7 Millimeter		
	Min	Nom	Max
A	--	--	1.60
A1	0.05	--	0.15
A2	1.35	1.40	1.45
b	0.30	--	0.45
c	0.09	--	0.20
D	8.80	9.00	9.20
D1	6.90	7.00	7.10
E	8.80	9.00	9.20
E1	6.90	7.00	7.10
e	0.80BSC		
L	0.45	--	0.75
L1	1.00REF		
θ	0	--	7°

**Note**

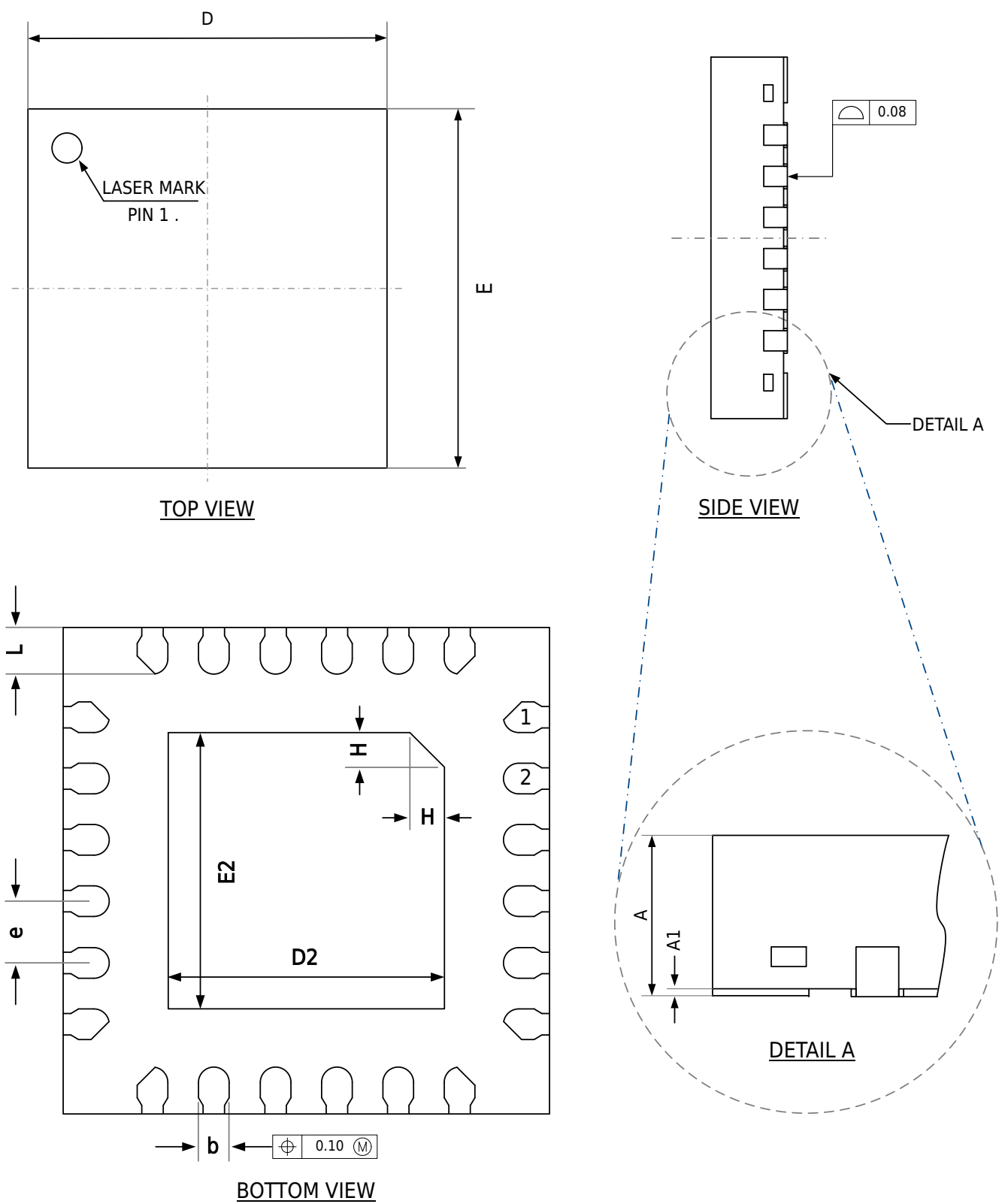
Dimensions "D1" and "E1" do not include mold flash.

6.1.2 QFN32 Package



Symbol	4*4 Millimeter		
	Min	Nom	Max
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
b	0.15	0.20	0.25
D	3.90	4.00	4.10
D2	2.85	2.90	2.95
e	0.40BSC		
E	3.90	4.00	4.10
E2	2.85	2.90	2.95
L	0.25	0.30	0.35
H	0.30REF		

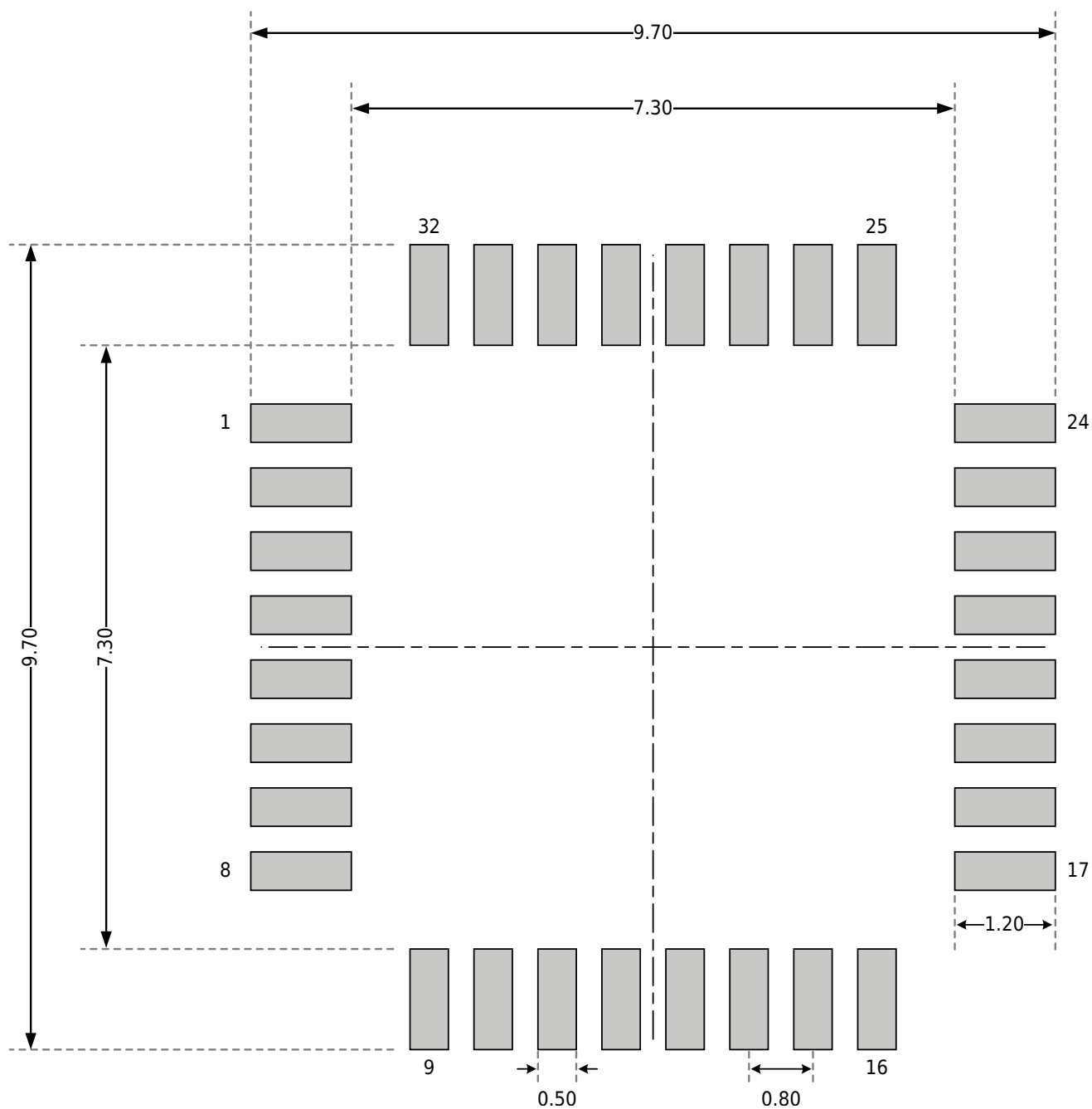
6.1.3 QFN24 Package



Symbol	4*4 Millimeter			3*3 Millimeter		
	Min	Nom	Max	Min	Nom	Max
A	0.70	0.75	0.80	0.50	0.55	0.60
A1	0.00	0.02	0.05	0.00	0.02	0.05
b	0.20	0.25	0.30	0.10	0.15	0.20
D	3.90	4.00	4.10	2.90	3.00	3.10
D2	2.60	2.65	2.70	1.90	2.05	2.23
E	3.90	4.00	4.10	2.90	3.00	3.10
E2	2.60	2.65	2.70	1.90	2.05	2.23
e	0.40	0.50	0.60	0.30	0.35	0.40
L	0.35	0.40	0.45	0.15	0.21	0.27
H	0.35REF			0.25REF		

6.2 PCB Land Pattern

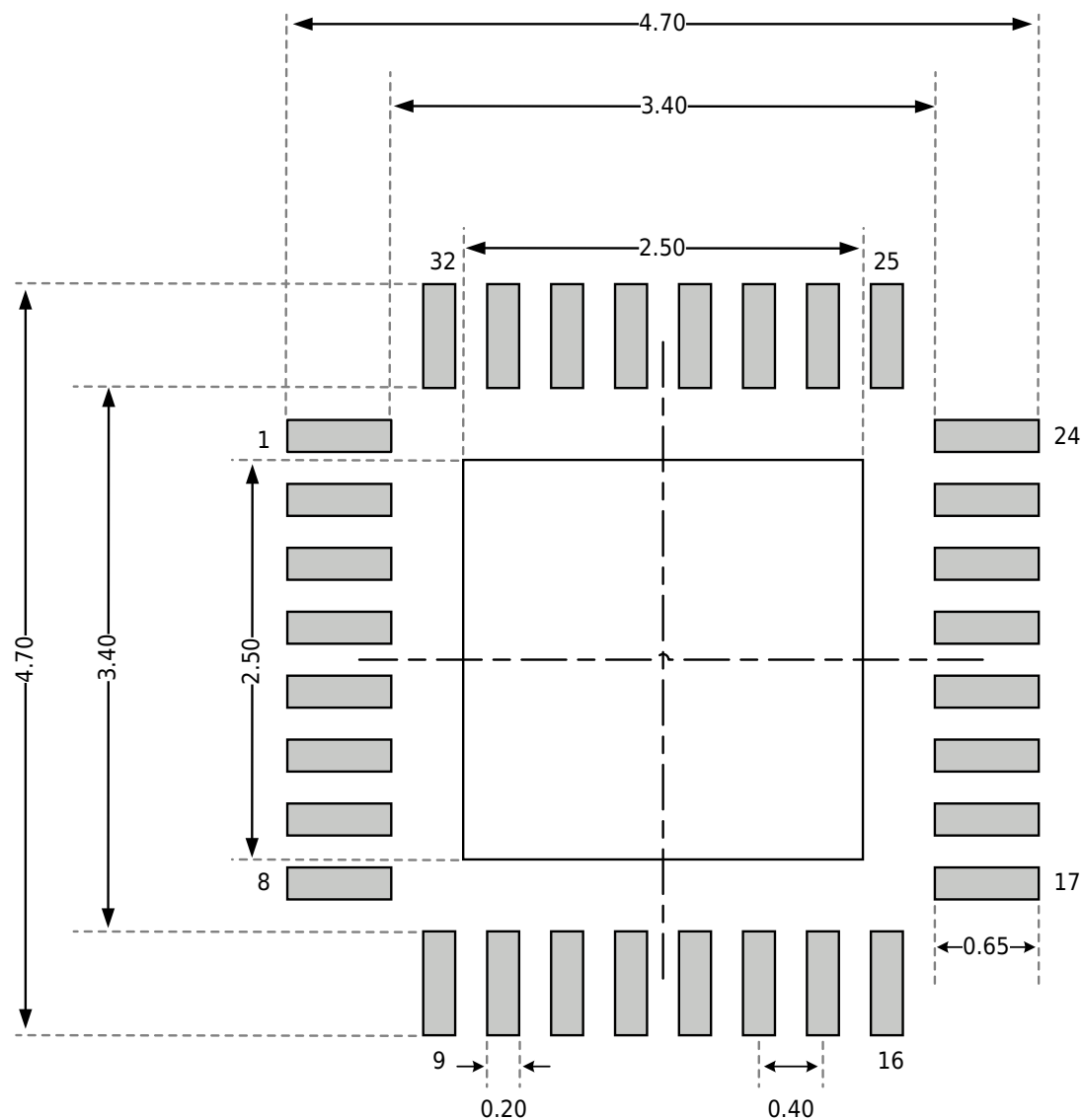
6.2.1 LQFP32 Package (7mm*7mm)



Note

- Dimensions are in millimeters.
- Dimensions are for reference only.

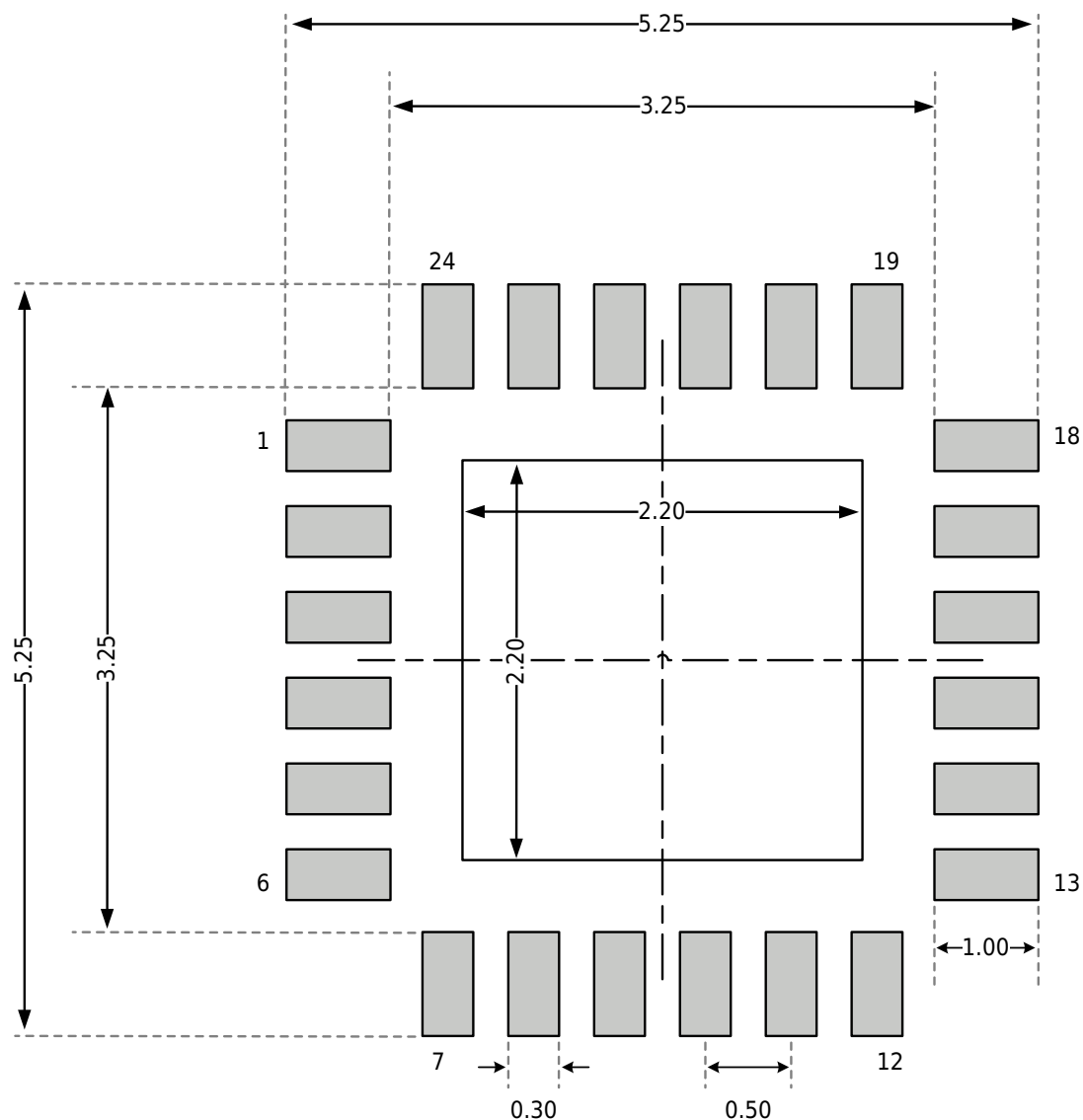
6.2.2 QFN32 Package (4mm*4mm)



Note

- Dimensions are in millimeters.
- Dimensions are for reference only.

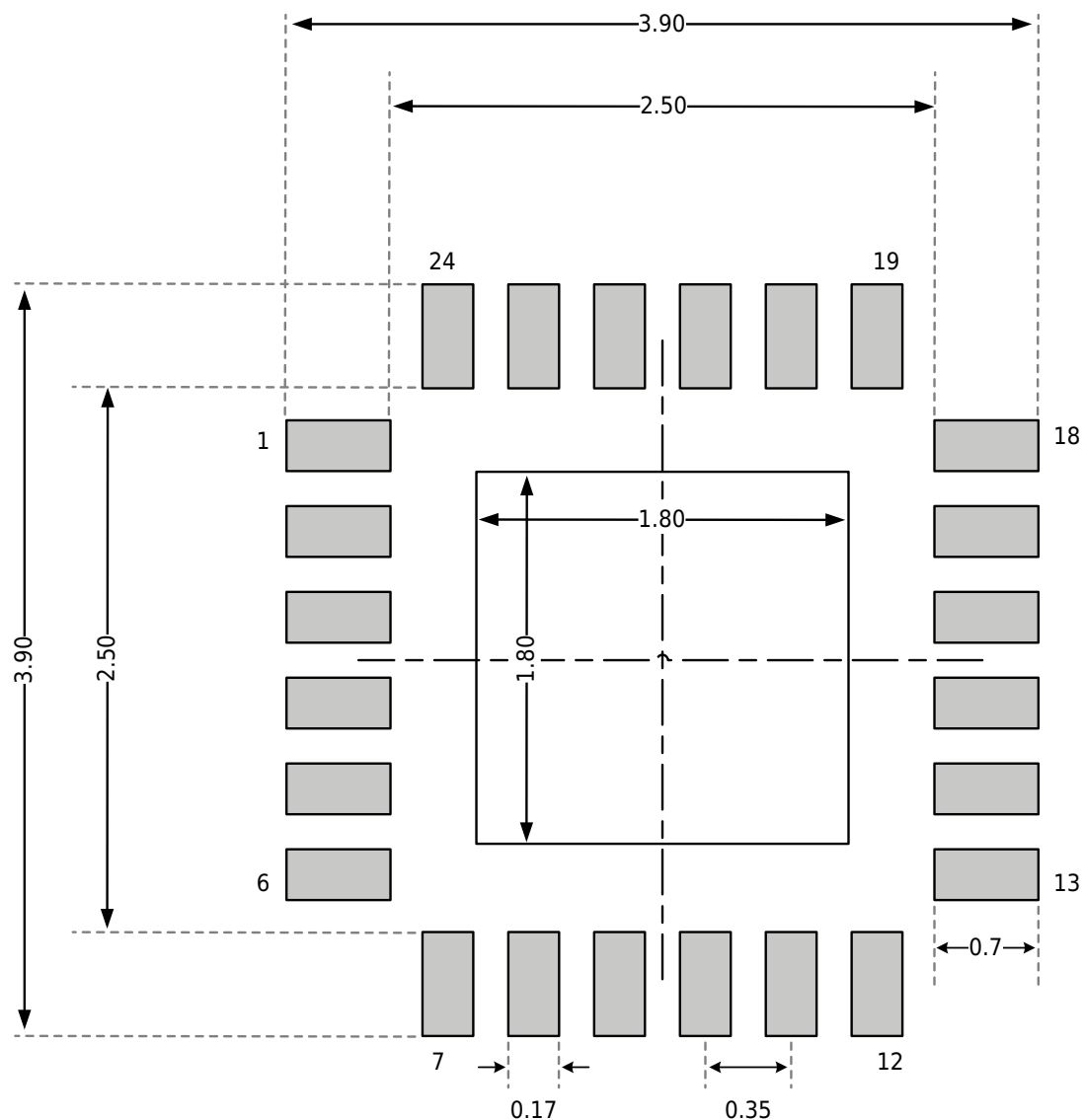
6.2.3 QFN24 Package (4mm*4mm)



Note

- Dimensions are in millimeters.
- Dimensions are for reference only.

6.2.4 QFN24 Package (3mm*3mm)



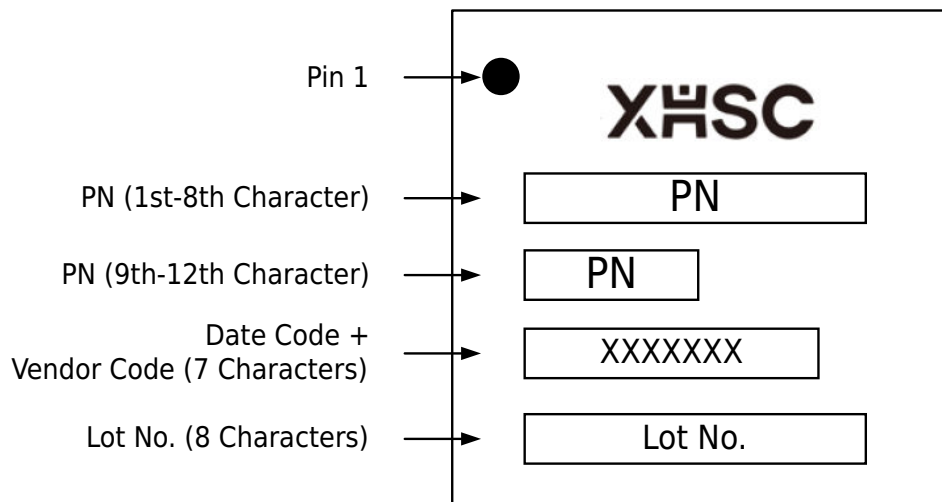
Note

- Dimensions are in millimeters.
- Dimensions are for reference only.

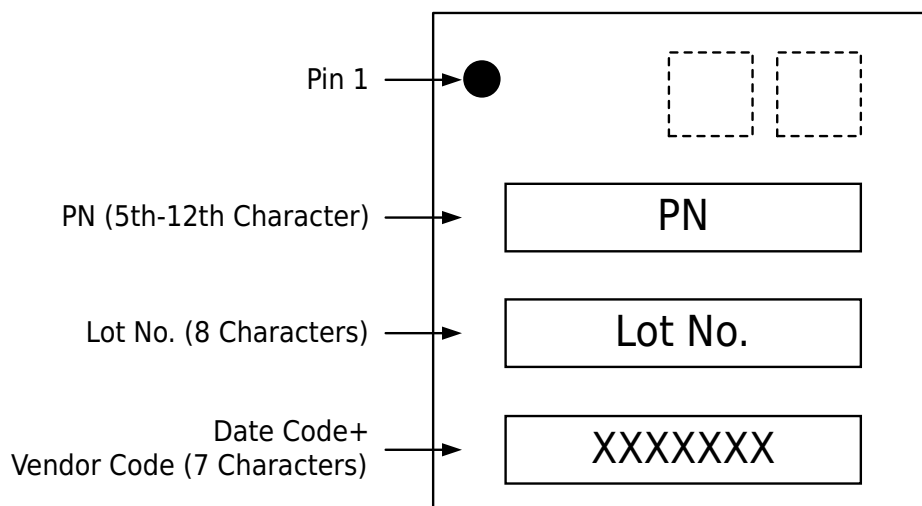
6.3 Package Marking

The location and information description of Pin1 on the front of each package are given below.

LQFP32 package (7mm*7mm)



QFN32 package (4mm*4mm)/QFN24 package (4mm*4mm)/QFN24 package (3mm*3mm)



Note

The blank boxes in the above figure indicate optional marks related to production, which are not explained in this section.

6.4 Packaging Thermal Resistance Coefficient

When the packaged chip is working at the specified working environment temperature, the junction temperature T_j (°C) of the chip surface can be calculated according to the following formula:

$$T_j = T_A + (P_D \cdot \theta_{JA})$$

- T_A refers to the working environment temperature when the packaged chip is working, the unit is °C;
- θ_{JA} refers to the thermal resistance coefficient of the package to the working environment, the unit is °C/W;

- P_D refers to total power dissipation, which is the sum of internal power consumption (P_{INT}) and I/O pin power consumption (P_{IO}), the unit is W.

$$P_D = P_{INT} + P_{IO}$$

► P_{INT} : Internal power consumption, calculated as the product of I_{VCC} and V_{CC} .

► P_{IO} : I/O pin power consumption, calculated as: $P_{IO} = \Sigma(V_{OL} * I_{OL}) + \Sigma((V_{CC} - V_{OH}) * I_{OH})$

When the chip is working at the specified working environment temperature, the junction temperature T_j of the chip surface cannot exceed the maximum allowable junction temperature T_{jmax} of the chip.

Table 6-4 Thermal Resistance Coefficient Reference Table For Each Package

Package Type and Dimensions	Thermal Resistance Parameters (θ_{JA})	Unit
LQFP32 7mm*7mm/0.8mm pitch	80±10%	°C/W
QFN32 4mm*4mm/0.4mm pitch	53±10%	°C/W
QFN24 4mm*4mm/0.5mm pitch	53±10%	°C/W
QFN24 3mm*3mm/0.35mm pitch	70 ± 10%	°C/W

7 Ordering Information

Part Number	HC32L031F8UB-QFN32TR	HC32L031F8TB-LQ32	HC32L031D8UB-QFN24TR	HC32L031D8UB-UFN24TR
GPIO	28+1	28+1	20+1	21+1
Core	Cortex-M0+	Cortex-M0+	Cortex-M0+	Cortex-M0+
Frequency	48MHz	48MHz	48MHz	48MHz
Flash	64KB	64KB	64KB	64KB
RAM	8KB	8KB	8KB	8KB
Power Supply Voltages	1.8-5.5V	1.8-5.5V	1.8-5.5V	1.8~5.5V
Temp Range	-40-105°C	-40-105°C	-40-105°C	-40~105°C
DMA	1*2ch	1*2ch	1*2ch	1*2ch
Basic Timer	[6] ⁽¹⁾	[6] ⁽¹⁾	[6] ⁽¹⁾⁽²⁾	[6] ⁽¹⁾
General Timer	2	2	2 ⁽²⁾	2
Advanced Timer	1	1	1	1
LPTimer	2	2	2	2
RTC	1	1	1	1
IWDT	1	1	1	1
LPUART	2	2	2	2
USART	1	1	1	1
7816	√	√	√	√
LIN	√	√	√	√
I2C	2	2	2	2
SPI	2	2	2	2
12-bit ADC	1*16ch	1*16ch	1*12ch	1*13ch
Vcomp	2	2	2	2
LVD	√	√	√	√
TRNG	1	1	1	1
Package (mm*mm)	QFN32 (4*4)	LQFP32 (7*7)	QFN24 (4*4)	QFN24 (3*3)
Pins	32	32	24	24
Packing	Tape & Reel	Tray	Tape & Reel	Tape & Reel
Pitch	0.4mm	0.8mm	0.5mm	0.35mm
Thickness	0.75mm	1.4mm	0.75mm	0.55mm



Note

1. This module is time-division multiplexed with the General Timer.
2. The partial output functions of CTIM0 are restricted.

Please contact the sales window for the latest mass production information before ordering.

Revision History

Revision/Date	Changes
Rev1.20 Aug. 28, 2026	1. Electrical Specifications: In the "Flash Memory Characteristics" chapter, delete the 100K data incorrectly added in EC_{FLASH} parameter; 2. Package Specifications: In the "PCB Land Pattern" chapter, the redundant data is removed; the size of EPAD in "QFN24 Package (3mm*3mm)" is revised from "1.90" to "1.80".
Rev1.10 Mar. 20, 2026	1. Added QFN24 3*3 package product: HC32L031D8UB-UFN24TR Modified related sections for product support description: ● Feature List: Added IO information and corresponding commercial model. ● Product Overview: Added QFN24 3*3 package product to the model function comparison table. ● Pin Definitions: Added corresponding pinout diagram for QFN24 3*3 package product in the "Pinout" chapter; added QFN24 3*3 package product information in the "Pin Function Description" chapter. ● Package Specifications: Added QFN24 3*3 product information in the "Package Dimensions", "PCB Land Pattern", "Package Marking", and "Packaging Thermal Resistance Coefficient" chapters. ● Ordering Information: Added ordering information for HC32L031D8UB-UFN24TR. 2. Feature List: Added typical applications. 3. Typical Application Circuit Diagram: Optimized power decoupling capacitor description. 4. Electrical Specifications: In the "Absolute Maximum Ratings" chapter, the voltage and current characteristics tables is merged; in the "RC48M" chapter, the Dev has reclassified and refreshed the data based on the dimensions of temperature and voltage, the I_{CLK} power consumption data has been updated, and a new graph depicting the frequency variation curve of the RC48M clock has been added; in the "RCL" chapter, the Dev has added precision data at 25°C and a new graph showing the frequency variation curve of the RCL clock; in the "EFT Characteristics" chapter, the data has been adjusted to TBD. 5. Package Specifications: Added Min and Nom data as "0.70, 0.75" for parameter A in the "QFN32 Package" section.
Rev1.01 Feb. 12, 2026	1. Product Overview: In the "Product Lineup" chapter, move the subscript of CTIM1 for the QFN24 product to CTIM0 in the model function comparison table, and simultaneously revise the corresponding description. 2. Electrical Specifications: In the "Flash Memory Characteristics" chapter, the data of EC_{FLASH} parameters have been optimized and updated based on new conditions. 3. Package Specifications: In the "Package Dimensions" chapter, the A2, A3, K, R, c of QFN package have been removed; In the "QFN32 Package" chapter, the max and min value of L is modified to "0.35, 0.25", the max and min value of D2/E2 is modified to "2.95, 2.85", the value of H (original "h") is modified to "0.30REF"; In

Revision/Date	Changes
Rev1.01 Feb. 12, 2026	the "QFN24 Package" chapter, the min value of b is modified to "0.20", the min value of D2/E2 is modified to "2.60".
Rev1.00 Nov. 7, 2025	First official release.